CC1100

CC1100 Single Chip Low Cost Low Power RF Transceiver

Applications

- Ultra low power UHF wireless transceivers
- 315/433/868 and 915 MHz ISM/SRD band systems
- AMR Automatic Meter Reading
- Consumer Electronics
- Two-way RKE Remote Keyless Entry

Product Description

The *CC1100* is a low cost true single chip UHF transceiver designed for very low power wireless applications. The circuit is mainly intended for the ISM (Industrial, Scientific and Medical) and SRD (Short Range Device) frequency bands at 315, 433, 868 and 915 MHz, but can easily be programmed for operation at other frequencies in the 300-348 MHz, 400-464 MHz and 800-928 MHz bands.

The RF transceiver is integrated with a highly configurable baseband modem. The modem supports various modulation formats and has a configurable data rate up to 500 kbps. The communication range can be increased by enabling a Forward Error Correction option, which is integrated in the modem.

CC1100 provides extensive hardware support for packet handling, data buffering, burst transmissions, clear channel assessment, link guality indication and wake-on-radio.

The main operating parameters and the 64byte transmit/receive FIFOs of *CC1100* can be controlled via an SPI interface. In a typical system, the *CC1100* will be used together with a

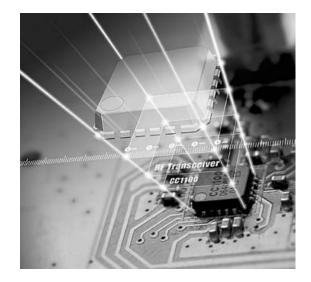
Key Features

- Small size (QLP 4x4 mm package, 20 pins)
- True single chip UHF RF transceiver
- Frequency bands: 300-348 MHz, 400-464 MHz and 800-928 MHz
- High sensitivity (–110 dBm at 1.2 kbps, 1% packet error rate)
- Programmable data rate up to 500 kbps
- Low current consumption (15.4 mA in RX, 1.2 kbps, 433 MHz)
- Programmable output power up to +10 dBm for all supported frequencies
- Excellent receiver selectivity and blocking performance

- Low power telemetry
- Home and building automation
- Wireless alarm and security systems
- Industrial monitoring and control
- Wireless sensor networks

microcontroller and a few additional passive components.

CC1100 is part of Chipcon's 4th generation technology platform based on 0.18 μ m CMOS technology.



- Very few external components: Totally onchip frequency synthesizer, no external filters or RF switch needed
- Programmable baseband modem
- Ideal for multi-channel operation
- Configurable packet handling hardware
- Suitable for frequency hopping systems due to a fast settling frequency synthesizer
- Optional Forward Error Correction with interleaving
- Separate 64-byte RX and TX data FIFOs
- Efficient SPI interface: All registers can be programmed with one "burst" transfer



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Features (continued from front page)

- Digital RSSI output
- Suited for systems compliant with EN 300 220 (Europe) and FCC CFR Part 15 (US)
- Wake-on-radio functionality for automatic low-power RX polling
- Many powerful digital features allow a high-performance RF system to be made using an inexpensive microcontroller
- Integrated analog temperature sensor
- Lead-free "green" package
- Flexible support for packet oriented systems: On chip support for sync word detection, address check, flexible packet length and automatic CRC handling
- Programmable channel filter bandwidth
- OOK and flexible ASK shaping supported
- FSK, GFSK and MSK supported.
- Automatic Frequency Compensation (AFC) can be used to align the frequency

synthesizer to the received centre frequency

- Optional automatic whitening and dewhitening of data
- Support for asynchronous transparent receive/transmit mode for backwards compatibility with existing radio communication protocols
- Programmable Carrier Sense (CS) indicator
- Programmable Preamble Quality Indicator (PQI) for detecting preambles and improved protection against sync word detection in random noise
- Support for automatic Clear Channel Assessment (CCA) before transmitting (for listen-before-talk systems)
- Support for per-package Link Quality
 Indication



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Abbreviations

Abbreviations used in this data sheet are described below.

ADC	Analog to Digital Converter	NRZ	Non Return to Zero (Coding)
AFC	Automatic Frequency Compensation	OOK	On-Off Keying
AGC	Automatic Gain Control	PA	Power Amplifier
AMR	Automatic Meter Reading	PCB	Printed Circuit Board
ASK	Amplitude Shift Keying	PD	Power Down
BER	Bit Error Rate	PER	Packet Error Rate
CCA	Clear Channel Assessment	PLL	Phase Locked Loop
CFR	Code of Federal Regulations	POR	Power-On Reset
CRC	Cyclic Redundancy Check	PQI	Preamble Quality Indicator
CW	Contionus Wave (Unmodulated Carrier)	PQT	Preamble Quality Threshold
CS	Carrier Sense	PTAT	Proportional To Absolute Temperature
DC	Direct Current	QLP	Quad Leadless Package
DVGA	Digital Variable Gain Amplifier	QPSK	Quadrature Phase Shift Keying
EIRP	Equivalent Isotropic Radiated Power	RC	Resistor-Capacitor
ESR	Equivalent Series Resistance	RCOSC	RC Oscillator
FCC	Federal Communications Commission	RF	Radio Frequency
FEC	Forward Error Correction	RSSI	Received Signal Strength Indicator
FIFO	First-In-First-Out	RX	Receive, Receive Mode
FSK	Frequency Shift Keying	SAW	Surface Aqustic Wave
GFSK	Gaussian shaped Frequency Shift Keying	SMD	Surface Mount Device
IF	Intermediate Frequency	SNR	Signal to Noise Ratio
ISM	Industrial, Scientific, Medical	SPI	Serial Peripheral Interface
LBT	Listen Before Transmit	SRD	Short Range Devices
LC	Inductor-Capacitor	TBD	To Be Defined
LNA	Low Noise Amplifier	T/R	Transmit/Receive
LO	Local Oscillator	ТХ	Transmit, Transmit Mode
LSB	Least Significant Byte	UHF	Ultra High frequency
LQI	Link Quality Indicator	VCO	Voltage Controlled Oscillator
MCU	Microcontroller Unit	WOR	Wake on Radio, Low power polling
MSK	Minimum Shift Keying	XOSC	Crystal Oscillator
N/A	Not Applicable	XTAL	Crystal





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1 Absolute Maximum Ratings

Under no circumstances must the absolute maximum ratings given in Table 1 be violated. Stress exceeding one or more of the limiting values may cause permanent damage to the device.

Caution!	ESD	sensitive	device.
		e used when	
	in order	to prevent p	ermanent
damage.			

Parameter	Min	Мах	Units	Condition
Supply voltage	-0.3	3.6	V	All supply pins must have the same voltage
Voltage on any digital pin	-0.3	VDD+0.3	V	
		max 3.6		
Voltage on the pins RF_P, RF_N and DCOUPL	-0.3	2.0	V	
Voltage ramp-up		120	kV/µs	
Input RF level		+10	dBm	
Storage temperature range	-50	150	°C	
Solder reflow temperature		260	°C	According to IPC/JEDEC J-STD-020C
ESD		<500	V	According to JEDEC STD 22, method A114, Human Body Model

Table 1: Absolute Maximum Ratings

2 **Operating Conditions**

The operating conditions for *CC1100* are listed Table 2 in below.

Parameter	Min	Max	Unit	Condition
Operating temperature	-40	85	°C	
Operating supply voltage	1.8	3.6	V	All supply pins must have the same voltage

Table 2: Operating Conditions

3 General Characteristics

Parameter	Min	Тур	Max	Unit	Condition/Note
Frequency range	300		348	MHz	
	400		464	MHz	
	800		928	MHz	
Data rate	1.2		500	kbps	FSK
	1.2		250	kbps	GFSK, OOK and ASK
	26		500	kbps	(Shaped) MSK (also known as differential offset QPSK)
					Optional Manchester encoding (halves the data rate).

Table 3: General Characteristics



4 Electrical Specifications

4.1 Current Consumption

Tc = 25°C, VDD = 3.0V if nothing else stated. All measurement results are obtained using the CC1100EM reference design.

Reduced current settings (MDMCFG2.DEM_DCFILT_OFF = 1) gives a slightly lower current consumption at the cost of a reduction in sensitivity. See Table 5 for additional details on current consumption and sensitivity.

Parameter	Min	Тур	Мах	Unit	Condition
Current consumption in power down modes		400		nA	Voltage regulator to digital part off, register values retained (SLEEP state)
		900		nA	Voltage regulator to digital part off, register values retained, low- power RC oscillator running (SLEEP state with WOR enabled)
		95		μA	Voltage regulator to digital part off, register values retained, XOSC running (SLEEP state with MCSM0.OSC_FORCE_ON set)
		160		μA	Voltage regulator to digital part on, all other modules in power down (XOFF state)
Current consumption		8.7		μA	Automatic RX polling once each second, using low-power RC oscillator, with 460 kHz filter bandwidth and 250 kbps data rate, PLL calibration every 4 th wakeup. Average current with signal in channel <i>below</i> carrier sense level.
		40		μA	Same as above, but with signal in channel <i>above</i> carrier sense level, 1.9ms RX timeout, and no preamble/sync word found.
		1.5		μA	Automatic RX polling every 15 th second, using low-power RC oscillator, with 460kHz filter bandwidth and 250kbps data rate, PLL calibration every 4 th wakeup. Average current with signal in channel below carrier sense level.
		46		μA	Same as above, but with signal in channel <i>above</i> carrier sense level, 37ms RX timeout, and no preamble/sync word found.
		1.6		mA	Only voltage regulator to digital part and crystal oscillator running (IDLE state)
		8.2		mA	Only the frequency synthesizer running (after going from IDLE until reaching RX or TX states, and frequency calibration states)
Current consumption,		27.0		mA	Transmit mode, +10dBm output power
315MHz		14.8			Transmit mode, 0dBm output power
		12.3			Transmit mode, -6dBm output power
		15.1			Receive mode, 1.2kbps, reduced current, input at sensitivity limit
		13.9			Receive mode, 1.2kbps, reduced current, input well above sensitivity limit
		14.9			Receive mode, 38.4kbps, reduced current, input at sensitivity limit
		14.1			Receive mode,38.4kbps, reduced current, input well above sensitivity limit
		16.0			Receive mode, 250kbps, reduced current, input at sensitivity limit
		14.5			Receive mode, 250kbps, reduced current, input well above sensitivity limit

Parameter	Min	Тур	Max	Unit	Condition
Current consumption,		28.9		mA	Transmit mode, +10dBm output power
433MHz		15.5			Transmit mode, 0dBm output power
		13.1			Transmit mode, –6dBm output power
		15.5			Receive mode, 1.2kbps, reduced current, input at sensitivity limit
		14.5			Receive mode, 1.2kbps, reduced current, input well above sensitivity limit
		15.3			Receive mode, 38.4kbps, reduced current, input at sensitivity limit
		14.3			Receive mode, 38.4kbps, reduced current, input well above sensitivity limit
		16.5			Receive mode, 250kbps, reduced current, input at sensitivity limit
		15.2			Receive mode, 250kbps, reduced current, input well above sensitivity limit
Current consumption,		30.7		mA	Transmit mode, +10dBm output power
868/915MHz		16.9			Transmit mode, 0dBm output power
		13.5			Transmit mode, -6dBm output power
		15.4			Receive mode, 1.2kbps, reduced current, input at sensitivity limit
		14.4			Receive mode, 1.2kbps, reduced current, input well above sensitivity limit
		15.2			Receive mode, 38.4kbps, reduced current, input at sensitivity limit
		14.4			Receive mode,38.4kbps, reduced current, input well above sensitivity limit
		16.4			Receive mode, 250kbps, reduced current, input at sensitivity limit
		15.1			Receive mode, 250kbps, reduced current, input well above sensitivity limit

Table 4: Electrical Specifications



4.2 RF Receive Section

Tc = 25°C, VDD = 3.0V if nothing else stated. All measurement results are obtained using the CC1100EM reference design.

Parameter	Min	Тур	Max	Unit	Condition/Note
Digital channel filter bandwidth	58		812	kHz	User programmable. The bandwidth limits are proportional to crystal frequency (stated values assume a 26.0 MHz crystal).
315 MHz, 1.2 kbps dat (FSK, 5.2kHz deviation		ket error	rate, 20 I	oytes pac	ket length, 58 kHz digital channel filter bandwidth)
Receiver sensitivity		-111		dBm	Sensitivity can be traded for current consumption by setting MDMCFG2.DEM_DCFILT_OFF = 1. The typical current consumption is then reduced from 17.1 mA to 15.1 mA at sensitivity llimit. The sensitivity is typically reduced to -110 dBm
315 MHz, 500 kbps da (MSK, 1% packet error		bytes pao	cket leng	th, 812 kł	Hz digital channel filter bandwidth)
		-88		dBm	
	I	I			
433 MHz, 1.2 kbps dat		ket error	rate 201	ovtes nac	ket length, 58 kHz digital channel filter bandwidth)
Receiver sensitivity		-111		dBm	Sensitivity can be traded for current consumption by setting MDMCFG2.DEM_DCFILT_OFF = 1. The typical current consumption is then reduced from 16.8 mA to 14.5 mA at sensitivity llimit. The sensitivity is typically reduced to -109 dBm
433 MHz, 38.4 kbps da					
	, 1% pack	1	rate, 20 b	1	ket length, 100 kHz digital channel filter bandwidth)
Receiver sensitivity		-102		dBm	
433 MHz, 250 kbps da (MSK, 1% packet error		bytes pao	cket leng	th, 540 kł	Hz digital channel filter bandwidth)
Receiver sensitivity		-93		dBm	
433 MHz, 500 kbps da (MSK, 1% packet error		bytes pad	cket lena	th. 812 kł	Hz digital channel filter bandwidth)
Receiver sensitivity	,	-88		dBm	
		00		ubiii	
868 MHz, 1.2 kbps dat (FSK, 5.2kHz deviation		ket error	rate, 20 I	oytes pac	ket length, 58 kHz digital channel filter bandwidth)
Receiver sensitivity		-111		dBm	Sensitivity can be traded for current consumption by setting MDMCFG2.DEM_DCFILT_OFF = 1. The typical current consumption is then reduced from 17.7 mA to 15.4 mA at sensitivity llimit. The sensitivity is typically reduced to -109 dBm
Saturation		-15		dBm	
Adjacent channel rejection		32		dB	Desired channel 3 dB above the sensitivity limit. 100 kHz channel spacing
Alternate channel rejection		33		dB	Desired channel 3 dB above the sensitivity limit. 100 kHz channel spacing
- 					See Figure 25 for plot of selectivity versus frequency offset
Image channel		30		dB	IF frequency 152 kHz
rejection,		00			
868MHz					Desired channel 3 dB above the sensitivity limit.

Parameter	Min	Тур	Max	Unit	Condition/Note
868 MHz, 38.4 kbps d (FSK, 20kHz deviation		ket error r	ate, 20 b	ytes pacł	ket length, 100 kHz digital channel filter bandwidth)
Receiver sensitivity		-103		dBm	
Saturation		-16		dBm	
Adjacent channel rejection		20		dB	Desired channel 3 dB above the sensitivity limit. 200 kHz channel spacing
Alternate channel rejection		29		dB	Desired channel 3 dB above the sensitivity limit. 200 kHz channel spacing
					See Figure 26 for plot of selectivity versus frequency offset
Image channel rejection,		23		dB	IF frequency 152 kHz
868MHz					Desired channel 3 dB above the sensitivity limit.
868 MHz, 250 kbps da (MSK, 1% packet erro	ata rate r rate, 20	bytes pad	ket lengt	:h, 540 k⊦	Hz digital channel filter bandwidth)
Receiver sensitivity		-93	j	dBm	Sensitivity can be traded for current consumption by setting
					MDMCFG2.DEM_DCFILT_OFF = 1. The typical current consumption is then reduced from 17.6 mA to 15.1 mA at sensitivity llimit. The sensitivity is typically reduced to -91 dBm
Saturation		-16		dBm	
Adjacent channel rejection		24		dB	Desired channel 3 dB above the sensitivity limit. 750 kHz channel spacing
Alternate channel rejection		38		dB	Desired channel 3 dB above the sensitivity limit. 750 kHz channel spacing
					See Figure 27 for plot of selectivity versus frequency offset
Image channel		14		dB	IF frequency 254 kHz
rejection, 868MHz					Desired channel 3 dB above the sensitivity limit.
868 MHz, 500 kbps da (MSK, 1% packet error		bytes pad	ket lengt	:h, 812 k⊦	Iz digital channel filter bandwidth)
Receiver sensitivity		-87		dBm	
868 MHz, 250 kbps da		bytes pag	cket lena	l th. 540 kł	I Hz digital channel filter bandwidth)
Receiver sensitivity		-88		dBm	
915 MHz, 1.2 kbps da (FSK, 5.2kHz deviation Receiver sensitivity		ket error	rate, 20 t	oytes pac dBm	ket length, 58 kHz digital channel filter bandwidth) Sensitivity can be traded for current consumption by setting
					MDMCFG2.DEM_DCFILT_OFF = 1. The typical current consumption is then reduced from 17.7 mA to 15.4 mA at sensitivity llimit. The sensitivity is typically reduced to -109 dBm
, i		ket error r	ate, 20 b	ytes pacl	ket length, 100 kHz digital channel filter bandwidth)
(FSK, 20kHz deviation		ket error r –103	ate, 20 b	ytes pacł dBm	ket length, 100 kHz digital channel filter bandwidth)
(FSK, 20kHz deviation Receiver sensitivity 915 MHz, 250 kbps da	i, 1% pacł	-103		dBm	ket length, 100 kHz digital channel filter bandwidth)
(FSK, 20kHz deviation Receiver sensitivity 915 MHz, 250 kbps da (MSK, 1% packet erro	i, 1% pacł	-103		dBm	
Receiver sensitivity 915 MHz, 250 kbps da (MSK, 1% packet erro Receiver sensitivity 915 MHz, 500 kbps da	ata rate r rate, 20	−103 bytes pac	cket lengt	dBm h, 540 kł dBm	Hz digital channel filter bandwidth) Sensitivity can be traded for current consumption by setting MDMCFG2.DEM_DCFILT_OFF = 1. The typical current consumption is then reduced from 17.6 mA to 15.1 mA at sensitivity llimit. The sensitivity is typically reduced to -91

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Parameter	Min	Тур	Max	Unit	Condition/Note
Blocking at 2MHz offset, 1.2 kbps, 868 MHz		-53		dBm	Desired channel 3dB above the sensitivity limit. Compliant to ETSI EN 300 220 class 2 receiver requirement.
Blocking at 2MHz offset, 500 kbps, 868 MHz		-51		dBm	Desired channel 3dB above the sensitivity limit. Compliant to ETSI EN 300 220 class 2 receiver requirement.
Blocking at 10MHz offset, 1.2 kbps, 868 MHz		-43		dBm	Desired channel 3dB above the sensitivity limit. Compliant to ETSI EN 300 220 class 2 receiver requirement.
Blocking at 10MHz offset, 500 kbps, 868 MHz		-43		dBm	Desired channel 3dB above the sensitivity limit. Compliant to ETSI EN 300 220 class 2 receiver requirement.
Spurious emissions		-68	-57	dBm	25 MHz – 1 GHz (Maximum figure is the ETSI EN 300 220 limit)
		-66	-47	dBm	Above 1 GHz (Maximum figure is the ETSI EN 300 220 limit)

Table 5: RF Receive Section



4.3 RF Transmit Section

Tc = 25° C, VDD = 3.0V, +10dBm if nothing else stated. All measurement results are obtained using the CC1100EM reference design.

Parameter	Min	Тур	Max	Unit	Condition/Note
Differential load impedance 315 MHz 433 MHz		122 + j31 116 + j41		Ω	Differential impedance as seen from the RF-port (RF_P and RF_N) towards the antenna. Follow the CC1100EM reference design available from theTI and Chipcon websites.
868/915 MHz		86.5 + j43			
Output power, highest setting		10		dBm	Output power is programmable, and full range is available in all frequency bands (Output power may be restricted by regulatory limits. See also application note 039).
					Delivered to a 50 Ω single-ended load via Chipcon reference RF matching network.
Output power, lowest setting		-30		dBm	Output power is programmable, and full range is available in all frequency bands.
					Delivered to a 50Ω single-ended load via Chipcon reference RF matching network.
Harmonics, radiated					Measured on CC1100EM reference design with CW, 10dBm output power
2 nd Harm, 433 MHz 3 rd Harm, 433 MHz		-50 -40		dBm	The antennas used during the radiated measurements (SMAFF-433 from R.W.Badland and Nearson
2 nd Harm, 868 MHz 3 rd Harm, 868 MHz		-34 -45			S331 868/915) plays a part in attenuating the harmonics
Harmonics, conducted					Measured with 10dBm CW, TX frequency at 315.00 MHz, 433.00 MHz, 868.00 MHz or 915.00 MHz
315 MHz		< -33 < -38		dBm	Frequencies below 960 MHz Frequencies above 960 MHz
433 MHz		< -51 < -34			Frequencies below 1 GHz Frequencies above 1 GHz
868 MHz		< -32			
915 MHz		< -31			
Spurious emissions , conducted Harmonics not included					Measured with 10dBm CW, TX frequency at 315.00 MHz, 433.00 MHz, 868.00 MHz or 915.00 MHz
315 MHz		< -58 < -53		dBm	Frequencies below 960 MHz Frequencies above 960 MHz
433 MHz		< -50 < -54 < -56			Frequencies below 1 GHz Frequencies above 1 GHz Frequencies within 47-74, 87.5-118, 174-230, 470-862 MHz
868 MHz		< -50 < -51 < -54			Frequencies below 1 GHz Frequencies above 1 GHz Frequencies within 47-74, 87.5-118, 174-230, 470-862 MHz
915 MHz		< -51 < -51			Frequencies below 960 MHz Frequencies above 960 MHz

Table 6: RF Transmit Parameters



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4.4 Crystal Oscillator

Tc = 25° C @ VDD = 3.0 V if nothing else is stated.

Parameter	Min	Тур	Max	Unit	Condition/Note
Crystal frequency	26	26	27	MHz	
Tolerance		±40		ppm	This is the total tolerance including a) initial tolerance, b) aging and c) temperature dependence. The acceptable crystal tolerance depends on RF frequency and channel spacing / bandwidth.
ESR			100	Ω	
Start-up time		180		μs	Measured on the CC1100EM reference design. This parameter is to a large degree crystal dependent.

Table 7: Crystal Oscillator Parameters

4.5 Low Power RC Oscillator

 $Tc = 25^{\circ}C$, VDD = 3.0 V if nothing else is stated. All measurement results obtained using the CC1100EM reference design.

Parameter	Min	Тур	Max	Unit	Condition/Note
Calibrated frequency	34.67	34.67	36	kHz	Calibrated RC Oscillator frequency is XTAL frequency divided by 750
Frequency accuracy after calibration			±0.3	%	
Temperature coefficient		+0.5		% / °C	Frequency drift when temperature changes after calibration
Supply voltage coefficient		+3		% / V	Frequency drift when supply voltage changes after calibration
Initial calibration time		2		ms	When the RC Oscillator is enabled, calibration is continuously done in the background as long as the crystal oscillator is running.

Table 8: I	RC Oscillator	parameters
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4.6 Frequency Synthesizer Characteristics

 $Tc = 25^{\circ}C @ VDD = 3.0 V$ if nothing else is stated. All measurement results are obtained using the CC1100EM reference design.

Parameter	Min	Тур	Max	Unit	Condition/Note
Programmed	397	F _{XOSC} / 2 ¹⁶	412	Hz	26MHz-27MHz crystal.
frequency resolution		2''			The resolution (in Hz) is equal for all frequency bands.
Synthesizer frequency tolerance		±40		ppm	Given by crystal used. Required accuracy (including temperature and aging) depends on frequency band and channel bandwidth / spacing.
RF carrier phase noise		-89		dBc/Hz	@ 50 kHz offset from carrier
RF carrier phase noise		-89		dBc/Hz	@ 100 kHz offset from carrier
RF carrier phase noise		-90		dBc/Hz	@ 200 kHz offset from carrier
RF carrier phase noise		-98		dBc/Hz	@ 500 kHz offset from carrier
RF carrier phase noise		-107		dBc/Hz	@ 1 MHz offset from carrier
RF carrier phase noise		-113		dBc/Hz	@ 2 MHz offset from carrier
RF carrier phase noise		-119		dBc/Hz	@ 5 MHz offset from carrier
RF carrier phase noise		-129		dBc/Hz	@ 10 MHz offset from carrier
PLL turn-on / hop time		88.4		μS	Time from leaving the IDLE state until arriving in the RX, FSTXON or TX state, when not performing calibration. Crystal oscillator running.
PLL RX/TX settling time		9.6		μs	Settling time for the 1xIF frequency step from RX to TX
PLL TX/RX settling time		21.5		μs	Settling time for the 1xIF frequency step from TX to RX
PLL calibration time		18739		XOSC cycles	Calibration can be initiated manually, or automatically before entering or after leaving RX/TX.
	0.69	0.72	0.72	ms	Min/typ/max time is for 27/26/26MHz crystal frequency.

Table 9: Frequency Synthesizer Parameters





4.7 Analog temperature sensor

The characteristics of the analog temperature sensor are listed in Table 10 below. Note that it is necessary to write 0xBF to the PTEST register to use the analog temperature sensor in the IDLE state.

Parameter	Min	Тур	Max	Unit	Condition/Note
Output voltage at -40°C		0.651		V	
Output voltage at 0°C		0.747		V	
Output voltage at +40°C		0.847		V	
Output voltage at +80°C		0.945		V	
Temperature coefficient		2.45		mV/°C	Fitted from –20°C to +80°C
Error in calculated temperature, calibrated	-2 [*]	0	2 *	°C	From –20°C to +80°C when using 2.54mV / °C, after 1-point calibration at room temperature
					[*] Indicated minimum and maximum error with 1- point calibration is based on simulated values for typical process parameters
Current consumption increase when enabled		0.3		mA	

Table 10: Analog Temperature Sensor Parameters

4.8 DC Characteristics

Tc = 25° C if nothing else stated.

Digital Inputs/Outputs	Min	Max	Unit	Condition
Logic "0" input voltage	0	0.7	V	
Logic "1" input voltage	VDD-0.7	VDD	V	
Logic "0" output voltage	0	0.5	V	For up to 4mA output current
Logic "1" output voltage	VDD-0.3	VDD	V	For up to 4mA output current
Logic "0" input current	N/A	-50	nA	Input equals 0V
Logic "1" input current	N/A	50	nA	Input equals VDD

Table 11: DC Characteristics

4.9 Power On Reset

When the power supply complies with the requirements in Table 12 below, proper Power-On-Reset functionality is guaranteed. Otherwise, the chip should be assumed to have unknown state until transmitting an SRES strobe over the SPI interface.

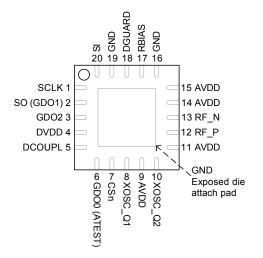
Parameter	Min	Тур	Max	Unit	Condition/Note
Power-up ramp-up time.			5	ms	From 0V until reaching 1.8V
Power off time	1			ms	Minimum time between power-on and power-off.

Table 12: Power-on Reset Requirements



CC1100

5 Pin Configuration





Note: The exposed die attach pad **must** be connected to a solid ground plane as this is the main ground connection for the chip.

1 SCLK Digital Input Serial configuration interface, clock input 2 SO (GDO1) Digital Output Serial configuration interface, data output. Optional general output pin when CSn is high 3 GDO2 Digital Output Digital output pin for general use: • Test signals • Clear Channel Indicator • Serial output RX data 4 DVDD Power (Digital) 1.8-3.6 V digital power supply for digital I/O's and for the digital core voltage regulator 5 DCOUPL Power (Digital) 1.6-2.0 V digital power supply for digital I/O's and for the digital core voltage regulator 6 GDO0 (ATEST) Digital I/O 1.6-2.0 V digital power supply output for decoupling. NOTE: This pin is interfaced for use with the <i>CTH00</i> only. It can not be used to provide supply voltage to other devices. 6 GDO0 (ATEST) Digital I/O Digital output pin for general use: • Test signals • FIFO status signals • Clear Channel Indicator • Serial output RX data • Serial output RX data 7 CSn Digital Input Serial configuration interface, chip select 8 XOSC_Q1 Analog I/O Crystal oscillator pin 1 9 AVDD Power (Analog) 1.8-3.6 V analog power supply connection 11 AVDD Power (Analog)	Pin #	Pin name	Pin type	Description	
(GD01)Optional general output pin when CSn is high3GD02Digital OutputDigital output pin for general use: • Test signals • FIFO status signals • Clear Channel Indicator • Serial output RX data4DVDDPower (Digital)1.8-3.8 V digital power supply or digital I/O's and for the digital core voltage regulator5DCOUPL DCOUPLPower (Digital)1.6-2.0 V digital power supply output for decoupling. NOTE: This pin is intended for use with the <i>CCT00</i> only. It can not be used to provide supply voltage to other devices.6GD00 (ATEST)Digital I/ODigital output RX data • Serial output RX data 	1	SCLK	Digital Input	Serial configuration interface, clock input	
Control and general use: Digital Output Digital output pin for general use: 3 GDO2 Digital Output Digital output pin for general use: 4 DVDD Power (Digital) 1.8-3.6 V digital power supply for digital I/O's and for the digital core voltage regulator 5 DCOUPL Power (Digital) 1.6-2.0 V digital power supply output for decoupling. NOTE: This pin is intended for use with the <i>CCH00</i> only. It can not be used to provide supply voltage to other devices. 6 GDO0 Digital I/O Digital output pin for general use: (ATEST) Power (Digital) 1.6-2.0 V digital power supply output for decoupling. NOTE: This pin is intended for use with the <i>CCH00</i> only. It can not be used to provide supply voltage to other devices. 6 GDO0 Digital I/O Digital output pin for general use: (ATEST) Power (Analog) Digital output pin tor general use: * FIFO status signals • FIFO status signals • CEar Channel Indicator • Serial output TX data * Serial output TX data Also used as analog test I/O for prototype/production testing 7 CSn Digital Input Serial output pin to general use: 8 XOSC_Q1 Analog I/O Crystal os	2	SO	Digital Output	Serial configuration interface, data output.	
Image: Second		(GD01)		Optional general output pin when CSn is high	
FIFO status signals • Clear Channel Indicator • Serial output RX data4DVDDPower (Digital)1.8-3.6 V digital power supply for digital I/O's and for the digital core vottage regulator5DCOUPLPower (Digital)1.8-2.0 V digital power supply output for decoupling. NOTE: This pin is intended for use with the <i>CC100</i> only. It can not be used to provide supply voltage to other devices.6GDO0 (ATEST)Digital I/ODigital output pin for general use: 	3	GDO2	Digital Output	Digital output pin for general use:	
Image: Clear Channel Indicator • Serial output RX data4DVDDPower (Digital)1.8-3.6 V digital power supply for digital I/O's and for the digital core voltage regulator5DCOUPLPower (Digital)1.6-2.0 V digital power supply output for decoupling. NOTE: This pin is intended for use with the <i>CCH00</i> only. It can not be used to provide supply voltage to other devices.6GDO0 (ATEST)Digital I/O Digital I/ODigital output pin for general use: • Test signals • FIFO status signals • FIFO status signals • Clear Channel Indicator • Serial output RX data Also used as analog test I/O for prototype/production testing7CSnDigital InputSerial configuration interface, chip select8XOSC_Q1Analog I/OCrystal oscillator pin 1, or external clock input9AVDDPower (Analog)1.8-3.6 V analog power supply connection10XOSC_Q2Analog I/OCrystal oscillator pin 211AVDDPower (Analog)1.8-3.6 V analog power supply connection12RF_PRF I/OPositive RF input signal to LNA in receive mode Negative RF output signal from PA in transmit mode13RF_NRF I/ONegative RF input signal from PA in transmit mode14AVDDPower (Analog)1.8-3.6 V analog power supply connection15AVDDPower (Analog)1.8-3.6 V analog power supply connection16GNDGround (Analog)Analog ground connection17REIASAnalog I/OExternal bias resistor for reference current18DGUARDPower (Digital)<				Test signals	
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18 DGUARD Power (Digital) Power supply connection for digital noise isolation 19 GND Ground (Digital) Ground connection for digital noise isolation	16	GND	Ground (Analog)	Analog ground connection	
19 GND Ground (Digital) Ground connection for digital noise isolation	17	RBIAS	Analog I/O	External bias resistor for reference current	
	18	DGUARD	Power (Digital)	Power supply connection for digital noise isolation	
20 SI Digital Input Serial configuration interface, data input	19	GND	Ground (Digital)	Ground connection for digital noise isolation	
	20	SI	Digital Input	Serial configuration interface, data input	

Table 13: Pinout overview

6 Circuit Description

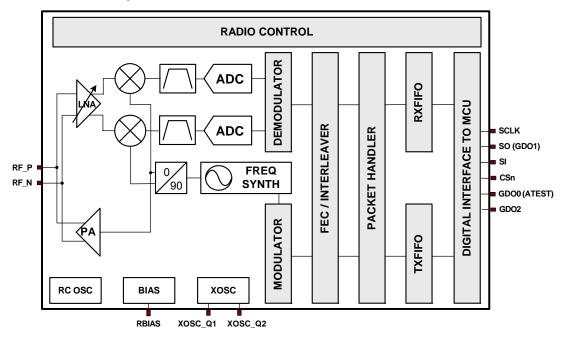


Figure 2: CC1100 Simplified Block Diagram

A simplified block diagram of *CC1100* is shown in Figure 2.

CC1100 features a low-IF receiver. The received RF signal is amplified by the low-noise amplifier (LNA) and down-converted in quadrature (I and Q) to the intermediate frequency (IF). At IF, the I/Q signals are digitised by the ADCs. Automatic gain control (AGC), fine channel filtering and demodulation bit/packet synchronization are performed digitally.

The transmitter part of *CC1100* is based on direct synthesis of the RF frequency. The

7 Application Circuit

Only a few external components are required for using the *CC1100*. The recommended application circuits are shown in Figure 3 and Figure 4. The external components are described in Table 14, and typical values are given in Table 15.

Bias resistor

The bias resistor R171 is used to set an accurate bias current reference.

Balun and RF matching

The components between the RF_N/RF_P pins and the point where the two signals are

frequency synthesizer includes a completely on-chip LC VCO and a 90 degree phase shifter for generating the I and Q LO signals to the down-conversion mixers in receive mode.

A crystal is to be connected to XOSC_Q1 and XOSC_Q2. The crystal oscillator generates the reference frequency for the synthesizer, as well as clocks for the ADC and the digital part.

A 4-wire SPI serial interface is used for configuration and data buffer access.

The digital baseband includes support for channel configuration, packet handling and data buffering.

joined together (C131, C121, L121 and L131 for the 315/433 MHz desgn. L121, L131, C121, L122, C131, C122 and L132 for the 868/915 MHz reference design) form a balun that converts the differential RF signal on *CC1100* to a single-ended RF signal (C124 is also needed for DC blocking). Together with an appropriate LC network, the balun components also transform the impedance to match a 50 Ω antenna (or cable). Suggested values for 315MHz, 433MHz and 868/915MHz are listed in Table 15.

The balun and LC filter component values and their placement are important to achieve





optimal performance. It is highly recommended to follow the CC1100EM reference design.

Crystal

The crystal oscillator uses an external crystal with two loading capacitors (C81 and C101). See section 25 on page 49 for details.

Additional filtering

Additional external components (e.g. an RF SAW filter) may be used in order to improve the performance in specific applications.

Power supply decoupling

The power supply must be properly decoupled close to the supply pins. Note that decoupling capacitors are not shown in the application circuit. The placement and the size of the decoupling capacitors are very important to achieve the optimum performance. The CC1100EM reference design should be followed closely.

Component	Description	
C51	100nF decoupling capacitor for on-chip voltage regulator to digital part	
C81/C101	Crystal loading capacitors, see section 25 on page 49 for details	
C121/C131	RF balun/matching capacitors	
C122	RF LC filter/matching filter capacitor (315 and 433 MHz). RF balun/matching capacitor (868/915 MHz).	
C123	RF LC filter/matching capacitor	
C124	RF balun DC blocking capacitor	
C125	RF LC filter DC blocking capacitor (only needed if there is a DC path in the antenna)	
L121/L131	1/L131 RF balun/matching inductors (inexpensive multi-layer type)	
L122	RF LC filter/matching filter inductor (315 and 433 MHz). RF balun/matching inductor (868/915 MHz). (inexpensive multi-layer type)	
L123	RF LC filter/matching filter inductor (inexpensive multi-layer type)	
L132	RF balun/matching inductor. (inexpensive multi-layer type)	
R171	56k Ω resistor for internal bias current reference. 1% tolerance	
XTAL	26MHz-27MHz crystal, see section 25 on page 49 for details	

Table 14: Overview of external components (excluding supply decoupling capacitors)

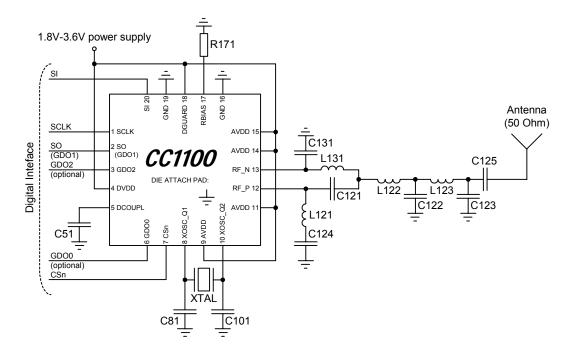


Figure 3: Typical application and evaluation circuit 315/433 MHz (excluding supply decoupling capacitors)

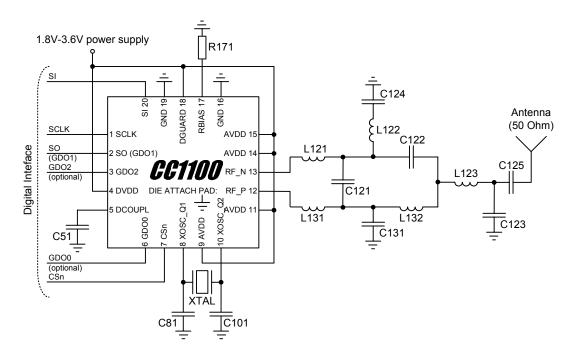


Figure 4: Typical application and evaluation circuit 868/915 MHz (excluding supply decoupling capacitors)

CC1100

Component	Value at 315MHz	Value at 433MHz	Value at 868/915MHz
C51		100nF±10%, 0402 X5R	
		,	
C81		27pF±5%, 0402 NP0	
C101		27pF±5%, 0402 NP0	
C121	6.8pF±0.5pF, 0402 NP0	3.9pF±0.25pF, 0402 NP0	1.0pF±0.25pF, 0402 NP0
C122	12pF±5%, 0402 NP0	8.2pF±0.5pF, 0402 NP0	1.5pF±0.25pF, 0402 NP0
C123	6.8pF±0.5pF, 0402 NP0	5.6pF±0.5pF, 0402 NP0	1.8pF±0.25pF, 0402 NP0
C124	220pF±5%, 0402 NP0	220pF±5%, 0402 NP0	100pF±5%, 0402 NP0
C125	220pF±5%, 0402 NP0	220pF±5%, 0402 NP0	100pF±5%, 0402 NP0
C131	6.8pF±0.5pF, 0402 NP0	3.9pF±0.25pF, 0402 NP0	1.5pF±0.25pF, 0402 NP0
L121	33nH±5%, 0402 monolithic	27nH±5%, 0402 monolithic	12nH±5%, 0402 monolithic
L122	18nH±5%, 0402 monolithic	22nH±5%, 0402 monolithic	18nH±5%, 0402 monolithic
L123	33nH±5%, 0402 monolithic	27nH±5%, 0402 monolithic	6.2nH±5%, 0402 monolithic
L131	33nH±5%, 0402 monolithic	27nH±5%, 0402 monolithic	12nH±5%, 0402 monolithic
L132			18nH±5%, 0402 monolithic
R171	56kΩ±1%, 0402		
XTAL		26.0MHz surface mount crysta	al

 Table 15: Bill Of Materials for the application circuit

In the CC1100EM reference designs shown in Figure 5 and Figure 6, LQG-15HS series inductors and GRM1555C series capacitors from Murata have been used.

The Gerber files for the CC1100EM reference designs are available from the TI and Chipcon websites.

CC1100



Figure 5: CC1100EM reference design, 433 MHz. Same PCB is used for 315 MHz



Figure 6: CC1100EM reference design, 868/915 MHz

8 Configuration Overview

CC1100 can be configured to achieve optimum performance for many different applications. Configuration is done using the SPI interface. The following key parameters can be programmed:

- Power-down / power up mode
- Crystal oscillator power-up / power-down
- Receive / transmit mode
- RF channel selection
- Data rate
- Modulation format
- RX channel filter bandwidth
- RF output power
- Data buffering with separate 64-byte receive and transmit FIFOs

- Packet radio hardware support
- Forward Error Correction with interleaving
- Data Whitening
- Wake-On-Radio (WOR)

Details of each configuration register can be found in section 31, starting on page 56.

Figure 7 shows a simplified state diagram that explains the main *CC1100* states, together with typical usage and current consumption. For detailed information on controlling the *CC1100* state machine, and a complete state diagram, see section 19, starting on page 41.

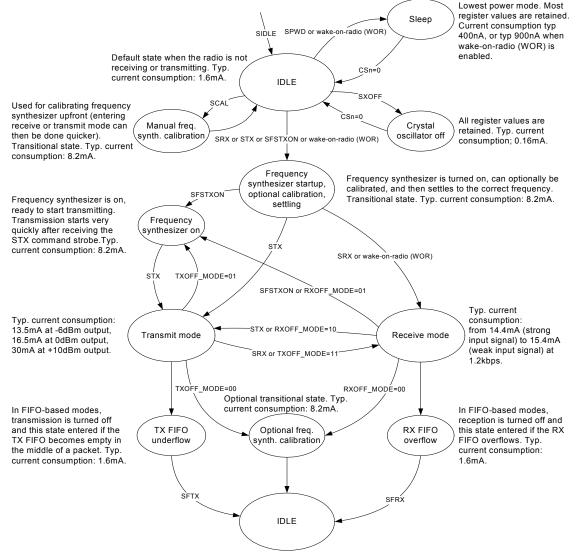


Figure 7: Simplified state diagram, with typical usage and current consumption



CC1100

9 Configuration Software

CC1100 can be configured using the SmartRF[®] Studio software, available for download from http://www.chipcon.com or www.ti.com/lpw. The SmartRF[®] Studio software is highly recommended for obtaining optimum register settings, and for evaluating performance and functionality. A screenshot of the SmartRF[®] Studio user interface for *CC1100* is shown in Figure 8.

© 0x0323 - CC1100 - SmartRF® Studio		
File Settings Help		
🗅 🖼 🖬 🕹 🖱		
Current chip values:	Normal View Register View Notes	
⊕ IOCF62 (0x00) 0x28 ⊕ IOCF61 (0x01) 0x2E ⊕ IOCF60 (0x02) 0x06 ⊕ IOCF6042 (0x02) 0x06 ⊕ IOCF6042 (0x02) 0x06 ⊕ IOCF6042 (0x02) 0x06 ⊕ IOCF6042 (0x02) 0x06 ⊕ FIFDTHR (0x03) 0x07 ⊕ SYNC1 (0x04) 0x03 ⊕ SYNC1 (0x05) 0x91 ⊕ PKTCTRL (0x07) 0x04 ⊕ PKTCTRL (0x08) 0x05 ⊕ DDR (0x03) 0x00 ⊕ CHANNR (0x04) 0x00 ⊕ FSCTRL (0x08) 0x06	Chip revision: F ✓ Crystal accuracy: X-tal frequency: RF output power: 40 ppm 26.000000 MHz O dBm PA ramping Deviation: 5157471 kHz 1.193484 kbps 2.6F5K Manchester RF frequency: Channel 2.4F5K Manchester RX filterbandwidth 58.035714 kH Preferred settings: Datarate 2.4F5K S8.Hz Manchester	BE Frequency -> FBEIJU 5:81
	2.4 kbps 5.2 kHz 2-GF5K 58 kHz · · · · · · · · · · · · · · · · · · ·	HF Frequency offset > FHE UDFF[/:0] MOMCFG4 = 0xF5 Data rate (exponent) > DRATE_E Channel bandwidth (mantissa) > CHANBW_E Channel bandwidth (mantissa) > CHANBW_M MOMCFG3 = 0x83 Data rate (mantissa) >> DRATE_M MDMCFG2 = 0x13
EDEVIATN (bx15): 0x15 MCSM2 (bx16): 0x07 MCSM1 (bx17): 0x30 MCSM0 (bx18): 0x18 FOCCFG (0x18): 0x18 EOCCFG (bx14): 0x6C	Simple RX Simple TX Packet RX Packet TX PER test Length config: Variable Sync word: 30/32 sy Address config: No Packet length: 255 Packet count: 200 Address: Image: Config: No	addre CBC Manual Init
MARCSTATE: (1) IDLE / IDLE	View format	MDMCFG1 = 0x20 Forward Error Correction -> FEC_EN MDMCFG2 = 0x03 Sync mode -> SYNC M0DE[2:0]
Frequency offset: 0.0 kHz CRC OK RSSI: NA Sync RX 0BW: 13.7 kHz Lock GDO2 output pin configuration.	File dump:	PKTCTRL0 = 0x05 Packetformat > PKT_F0BMAT[1:0] CRC operation > CRC_EN Packet config > LENGTH_CONFIG[1:0] PKTCTRL1 = 0x04 Address check > ADR_CHK[1:0] FIFD autoflush > CRC_AUTOFLUSH
	Start buffered RX	Stop RX
Device ID: 0x0323	Last executed command: Dat	e: 26.04.2006. Time: 10:52:08

Figure 8: SmartRF[®] Studio user interface

10 4-wire Serial Configuration and Data Interface

CC1100 is configured via a simple 4-wire SPIcompatible interface (SI, SO, SCLK and CSn) where *CC1100* is the slave. This interface is also used to read and write buffered data. All address and data transfer on the SPI interface is done most significant bit first.

All transactions on the SPI interface start with a header byte containing a read/write bit, a burst access bit and a 6-bit address.

During address and data transfer, the CSn pin (Chip Select, active low) must be kept low. If CSn goes high during the access, the transfer

will be cancelled. The timing for the address and data transfer on the SPI interface is shown in Figure 9 with reference to Table 16.

When CSn goes low, the MCU must wait until *CC1100* SO pin goes low before starting to transfer the header byte. This indicates that the voltage regulator has stabilized and the crystal is running. Unless the chip was in the SLEEP or XOFF states, the SO pin will always go low immediately after taking CSn low.

Figure 10 gives a brief overview of different register access types possible.

CC1100

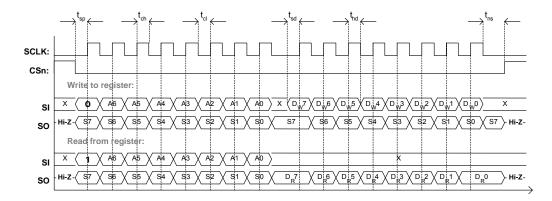


Figure 9: Configuration registers write and read operations

Parameter	Description		Min	Max	Units
f _{SCLK}	SCLK frequency 100 ns delay inserted between address byte and data byte (s between address and data, and between each data byte (bur		-	10	MHz
	SCLK frequency, single access No delay between address and data byte		-	9	
	SCLK frequency, burst access No delay between address and data byte, or between data b	ytes	-	6.5	
t _{sp,pd}	CSn low to positive edge on SCLK, in power	r-down mode	200	-	μS
t _{sp}	CSn low to positive edge on SCLK, in active	mode	20	-	ns
t _{ch}	Clock high		50	-	ns
t _{cl}	Clock low	50	-	ns	
t _{rise}	Clock rise time		-	5	ns
t _{fall}	Clock fall time		-	5	ns
t _{sd}	Setup data (negative SCLK edge) to	Single access	55	-	ns
	positive edge on $SCLK$ $(t_{sd} applies between address and data bytes, and between data bytes)$	Burst access	76	-	
t _{hd}	Hold data after positive edge on SCLK		20	-	ns
t _{ns}	Negative edge on SCLK to CSn high.		20	-	ns

Table 16: SPI interface timing requirements

CSn:	
Command strobe(s):	ADDR ADDR ADDR ADDR ADDR ADDR ADDR ADDR
Read or write register(s):	$\langle \text{ADDR}_{eg} \rangle \langle \text{DATA} \rangle \langle \text{ADDR}_{eg} \rangle \langle \text{DATA} \rangle \langle \text{ADDR}_{eg} \rangle \langle \text{DATA} \rangle \dots$
Read or write consecutive registers (burst):	$\langle ADDR_{ggn} \rangle \langle DATA \rangle \langle DATA_{+1} \rangle \langle DATA_{+2} \rangle \dots$
Read or write n+1 bytes from/to RF FIFO:	(ADDRATA VIE D) (DATA VIE D) (DATA VIE D) (DATA VIE D) (DATA VIE D)
Combinations:	$\label{eq:address} $$ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \$

Figure 10: Register access types



CC1100

10.1 Chip Status Byte

When the header byte, data byte or command strobe is sent on the SPI interface, the chip status byte is sent by the *CC1100* on the SO pin. The status byte contains key status signals, useful for the MCU. The first bit, s7, is the CHIP_RDYn signal; this signal must go low before the first positive edge of SCLK. The CHIP_RDYn signal indicates that the crystal is running and the regulated digital supply voltage is stable.

Bits 6, 5 and 4 comprises the STATE value. This value reflects the state of the chip. The XOSC and power to the digital core is on in the IDLE state, but all other modules are in power down. The frequency and channel configuration should only be updated when the chip is in this state. The RX state will be active when the chip is in receive mode. Likewise, TX is active when the chip is transmitting.

The last four bits (3:0) in the status byte contains FIFO_BYTES_AVAILABLE. For read operations, the FIFO_BYTES_AVAILABLE field contains the number of bytes available for reading from the RX FIFO. For write operations, the FIFO_BYTES_AVAILABLE field contains the number of bytes free for writing into the TX FIFO. When FIFO_BYTES_AVAILABLE=15, 15 or more bytes are available/free.

Table 17 gives a status byte summary.

Bits	Name	Descript	Description		
7	CHIP_RDYn	Stays high until power and crystal have stabilized. Should always be low when using the SPI interface.			
6:4	STATE[2:0]	Indicates	the current main state ma	chine mode	
		Value	State	Description	
		000	ldle	IDLE state (Also reported for some transitional states instead of SETTLING or CALIBRATE, due to a small error)	
		001	RX	Receive mode	
		010	ТХ	Transmit mode	
		011	FSTXON	Fast TX ready	
		100	CALIBRATE	Frequency synthesizer calibration is running	
		101	SETTLING	PLL is settling	
		110	RXFIFO_OVERFLOW	RX FIFO has overflowed. Read out any useful data, then flush the FIFO with SFRX	
		111	TXFIFO_UNDERFLOW	TX FIFO has underflowed. Acknowledge with SFTX	
3:0	FIFO_BYTES_AVAILABLE[3:0]	The number of bytes available in the RX FIFO or free bytes in the TX FIFO (depends on the read/write-bit). If FIFO_BYTES_AVAILABLE=15, it indicates that 15 or more bytes are available/free.			

Table 17: Status byte summary

10.2 Register Access

The configuration registers on the *CC1100* are located on SPI addresses from $0 \ge 00$ to $0 \ge 2F$. Table 35 on page 58 lists all configuration registers. The detailed description of each register is found in Section 31.1, starting on page 61. All configuration registers can be both written to and read. The read/write bit

controls if the register should be written to or read. When writing to registers, the status byte is sent on the SO pin each time a header byte or data byte is transmitted on the SI pin. When reading from registers, the status byte is

sent on the SO pin each time a header byte is transmitted on the SI pin.

Registers with consecutive addresses can be accessed in an efficient way by setting the burst bit in the address header. The address sets the start address in an internal address counter. This counter is incremented by one each new byte (every 8 clock pulses). The burst access is either a read or a write access and must be terminated by setting CSn high.

For register addresses in the range 0x30-0x3D, the "burst" bit is used to select between status registers and command strobes (see below). The status registers can only be read. Burst read is not available for status registers, so they must be read one at a time.

10.3 SPI Read

When reading register fields over the SPI interface while the register fields are updated by the radio hardware (e.g. MARCSTATE or TXBYTES), there is a small, but finite, probability that a single read from the register being corrupt. As an example, the probability of any single read from TXBYTES being corrupt, assuming the maximum data rate is used, is approximately 80 ppm. Refer to the *CC1100* Errata Note for more details.

10.4 Command Strobes

Command Strobes may be viewed as single byte instructions to *CC1100*. By addressing a Command Strobe register, internal sequences will be started. These commands are used to disable the crystal oscillator, enable receive mode, enable wake-on-radio etc. The 14 command strobes are listed in Table 34 on page 57.

The command strobe registers are accessed in the same way as for a register write operation, but no data is transferred. That is, only the R/W bit (set to 0), burst access (set to 0) and the six address bits (in the range 0x30 through 0x3D) are written.

When writing command strobes, the status byte is sent on the SO pin.

A command strobe may be followed by any other SPI access without pulling CSn high. After issuing an SRES command strobe the next command strobe can be issued when the SO pin goes low as shown in Figure 11 The command strobes are executed immediately, with the exception of the SPWD and the SXOFF strobes that are executed when $\ensuremath{\mathtt{CSn}}$ goes high.

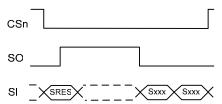


Figure 11: SRES command strobe

10.5 FIFO Access

The 64-byte TX FIFO and the 64-byte RX FIFO are accessed through the 0x3F address. When the read/write bit is zero, the TX FIFO is accessed, and the RX FIFO is accessed when the read/write bit is one.

The TX FIFO is write-only, while the RX FIFO is read-only.

The burst bit is used to determine if FIFO access is single byte or a burst access. The single byte access method expects address with burst bit set to zero and one data byte. After the data byte a new address is expected; hence, CSn can remain low. The burst access method expects one address byte and then consecutive data bytes until terminating the access by setting CSn high.

The following header bytes access the FIFOs:

- 0x3F: Single byte access to TX FIFO
- 0x7F: Burst access to TX FIFO
- 0xBF: Single byte access to RX FIFO
- 0xFF: Burst access to RX FIFO

When writing to the TX FIFO, the status byte (see Section 10.1) is output for each new data byte on SO, as shown in Figure 9. This status byte can be used to detect TX FIFO underflow while writing data to the TX FIFO. Note that the status byte contains the number of bytes free *before* writing the byte in progress to the TX FIFO. When the last byte that fits in the TX FIFO is transmitted to the SI pin, the status byte received concurrently on the SO pin will indicate that one byte is free in the TX FIFO.

The transmit FIFO may be flushed by issuing a SFTX command strobe. Similarly, a SFRX command strobe will flush the receive FIFO. A SFTX or SFRX command strobe can only be issued in the IDLE, TXFIFO_UNDERLOW or

RXFIFO_OVERFLOW state. Both FIFOs are flushed when going to the SLEEP state.

10.6 PATABLE Access

The 0x3E address is used to access the PATABLE, which is used for selecting PA power control settings. The SPI expects up to eight data bytes after receiving the address. By programming the PATABLE, controlled PA power ramp-up and ramp-down can be achieved, as well as ASK modulation shaping for reduced bandwidth. Note that the ASK modulation shaping is limited to output powers below -1 dBm, and the PATABLE settings allowed for ASK is 0x30 to 0x3F. See SmartRF[®] Studio for recommended shaping sequence.

See section 24 on page 48 for details on output power programming.

The PATABLE is an 8-byte table that defines the PA control settings to use for each of the eight PA power values (selected by the 3-bit value FRENDO.PA_POWER). The table is written and read from the lowest setting (0) to the highest (7), one byte at a time. An index counter is used to control the access to the table. This counter is incremented each time a byte is read or written to the table, and set to the lowest index when CSn is high. When the highest value is reached the counter restarts at zero.

The access to the PATABLE is either single byte or burst access depending on the burst bit. When using burst access the index counter will count up; when reaching 7 the counter will restart at 0. The read/write bit controls whether the access is a write access (R/W=0) or a read access (R/W=1).

If one byte is written to the PATABLE and this value is to be read out then CSn must be set high before the read access in order to set the index counter back to zero.

Note that the content of the PATABLE is lost when entering the SLEEP state, except for the first byte (index 0).

11 Microcontroller Interface and Pin Configuration

In a typical system, *CC1100* will interface to a microcontroller. This microcontroller must be able to:

- Program *CC1100* into different modes,
- Read and write buffered data
- Read back status information via the 4-wire SPI-bus configuration interface (SI, SO, SCLK and CSn).

11.1 Configuration Interface

The microcontroller uses four I/O pins for the SPI configuration interface (SI, SO, SCLK and CSn). The SPI is described in Section 10 on page 24.

11.2 General Control and Status Pins

The *CC1100* has two dedicated configurable pins and one shared pin that can output internal status information useful for control software. These pins can be used to generate interrupts on the MCU. See Section 28 page 52 for more details on the signals that can be programmed. The dedicated pins are called

GD00 and GD02. The shared pin is the S0 pin in the SPI interface. The default setting for GD01/S0 is 3-state output. By selecting any other of the programming options the GD01/S0 pin will become a generic pin. When CSn is low, the pin will always function as a normal S0 pin.

In the synchronous and asynchronous serial modes, the GDO0 pin is used as a serial TX data input pin while in transmit mode.

The GDO0 pin can also be used for an on-chip analog temperature sensor. By measuring the voltage on the GDO0 pin with an external ADC, the temperature can be calculated. Specifications for the temperature sensor are found in section 4.7 on page 16.

With default PTEST register setting (0x7F) the temperature sensor output is only available when the frequency synthesizer is enabled (e.g. the MANCAL, FSTXON, RX and TX states). It is necessary to write 0xBF to the PTEST register to use the analog temperature sensor in the IDLE state. Before leaving the IDLE state, the PTEST register should be restored to its default value (0x7F).

11.3 Optional radio control feature

The *CC1100* has an optional way of controlling the radio, by reusing SI, SCLK and CSn from the SPI interface. This feature allows for a simple three-pin control of the major states of the radio: SLEEP, IDLE, RX and TX.

This optional functionality is enabled with the MCSM0.PIN_CTRL_EN configuration bit.

State changes are commanded as follows when CSn is high the SI and SCLK is set to the desired state according to Table 18. When CSn goes low the state of SI and SCLK is latched and a command strobe is generated internally according to the pin configuration. It is only possible to change state with this functionality. That means that for instance RX will not be restarted if SI and SCLK are set to RX and CSn toggles. When CSn is low the SI and SCLK has normal SPI functionality.

12 Data Rate Programming

The data rate used when transmitting, or the data rate expected in receive is programmed by the MDMCFG3.DRATE_M and the MDMCFG4.DRATE_E configuration registers. The data rate is given by the formula below. As the formula shows, the programmed data rate depends on the crystal frequency.

$$R_{DATA} = \frac{\left(256 + DRATE_M\right) \cdot 2^{DRATE_E}}{2^{28}} \cdot f_{XOSC}$$

The following approach can be used to find suitable values for a given data rate:

$$DRATE _ E = \left\lfloor \log_2 \left(\frac{R_{DATA} \cdot 2^{20}}{f_{XOSC}} \right) \right\rfloor$$
$$DRATE _ M = \frac{R_{DATA} \cdot 2^{28}}{f_{XOSC} \cdot 2^{DRATE_E}} - 256$$

If DRATE_M is rounded to the nearest integer and becomes 256, increment DRATE_E and use DRATE_M=0.

13 Receiver Channel Filter Bandwidth

In order to meet different channel width requirements, the receiver channel filter is programmable. The MDMCFG4.CHANBW_E and

TEXAS INSTRUMENTS All pin control command strobes are executed immediately, except the SPWD strobe, which is delayed until CSn goes high.

CSn	SCLK	SI	Function
1	Х	х	Chip unaffected by SCLK/SI
\downarrow	0	0	Generates SPWD strobe
\downarrow	0	1	Generates STX strobe
\downarrow	1	0	Generates SIDLE strobe
\downarrow	1	1	Generates SRX strobe
0	SPI mode	SPI mode	SPI mode (wakes up into IDLE if in SLEEP/XOFF)

Table 18: Optional pin control coding

The data rate can be set from 1.2 kbps to 500

kbps with the minimum step size of:

Min Data rate [kbps]	Typical data rate [kbps]	Max Data rate [kbps]	Data rate step size [kbps]
0.8	1.2 / 2.4	3.17	0.0062
3.17	4.8	6.35	0.0124
6.35	9.6	12.7	0.0248
12.7	19.6	25.4	0.0496
25.4	38.4	50.8	0.0992
50.8	76.8	101.6	0.1984
101.6	153.6	203.1	0.3967
203.1	250	406.3	0.7935
406.3	500	500	1.5869

Table 19: Data rate step size

MDMCFG4.CHANBW_M configuration registers control the receiver channel filter bandwidth, which scales with the crystal oscillator

frequency. The following formula gives the relation between the register settings and the channel filter bandwidth:

$$BW_{channel} = \frac{f_{XOSC}}{8 \cdot (4 + CHANBW_M) \cdot 2^{CHANBW_E}}$$

The *CC1100* supports the following channel filter bandwidths:

	Channel filter bandwidth [kHz]		MDMCFG4.CHANBW_E				
			01	10	11		
.₹ •	00	812	406	203	102		
BV	01	650	325	162	81		
MDMCFG4. CHANBW_M	10	541	270	135	68		
≥ç	11	464	232	116	58		

Table 20: Channel filter bandwidths (assuming a 26MHz crystal)

For best performance, the channel filter bandwidth should be selected so that the signal bandwidth occupies at most 80% of the channel filter bandwidth. The channel centre tolerance due to crystal accuracy should also be subtracted from the signal bandwidth. The following example illustrates this:

With the channel filter bandwidth set to 500kHz, the signal should stay within 80% of 500kHz, which is 400kHz. Assuming 915MHz frequency and \pm 20ppm frequency uncertainty for both the transmitting device and the receiving device, the total frequency uncertainty is \pm 40ppm of 915MHz, which is \pm 37kHz. If the whole transmitted signal bandwidth is to be received within 400kHz, the transmitted signal bandwidth should be maximum 400kHz–2·37kHz, which is 326kHz.

14 Demodulator, Symbol Synchronizer and Data Decision

CC1100 contains an advanced and highly configurable demodulator. Channel filtering and frequency offset compensation is performed digitally. To generate the RSSI level (see section 17.3 for more information) the signal level in the channel is estimated. Data filtering is also included for enhanced performance.

14.1 Frequency Offset Compensation

When using FSK, GFSK or MSK modulation, the demodulator will compensate for the offset between the transmitter and receiver frequency, within certain limits, by estimating the centre of the received data. This value is available in the FREQEST status register.

When writing the value from FREQEST into FSCTRL0.FREQOFF the frequency synthesizer is automatically adjusted according to the estimated frequency offset.

Note that frequency offset compensation is not supported for ASK or OOK modulation.

14.2 Bit Synchronization

The bit synchronization algorithm extracts the clock from the incoming symbols. The algorithm requires that the expected data rate is programmed as described in Section 12 on

page 29. Re-synchronization is performed continuously to adjust for error in the incoming symbol rate.

14.3 Byte synchronization

Byte synchronization is achieved by a continuous sync word search. The sync word is a 16 or 32 bit configurable field that is automatically inserted at the start of the packet by the modulator in transmit mode. The demodulator uses this field to find the byte boundaries in the stream of bits. The sync word will also function as a system identifier, since only packets with the correct predefined sync word will be received. The sync word detector correlates against the user-configured 16-bit sync word. The correlation threshold can be set to 15/16 bits match or 16/16 bits match. The sync word can be further gualified using the preamble quality indicator mechanism described below and/or a carrier condition. The sync word sense is programmed with SYNC1 and SYNC0.

In order to make false detections of sync words less likely, a mechanism called preamble quality indication (PQI) can be used to qualify the sync word. A threshold value for the preamble quality must be exceeded in order for a detected sync word to be accepted. See section 17.2 on page 36 for more details.

15 Packet Handling Hardware Support

The *CC1100* has built-in hardware support for packet oriented radio protocols.

In transmit mode, the packet handler will add the following elements to the packet stored in the TX FIFO:

- A programmable number of preamble bytes.
- A two byte synchronization (sync.) word. Can be duplicated to give a 4-byte sync word (Recommended).
- Optionally whiten the data with a PN9 sequence.
- Optionally Interleave and Forward Error Code the data.
- Optionally compute and add a CRC checksum over the data field.
- The recommended setting is 4-byte preamble and 4-byte sync word, except for 500 kbps data rate where the recommended preamble length is 8 bytes.

In receive mode, the packet handling support will de-construct the data packet:

- Preamble detection.
- Sync word detection.
- Optional one byte address check.
- Optionally compute and check CRC.
- Optionally append two status bytes (see Table 21 and Table 22) with RSSI value, Link Quality Indication and CRC status.

Bit	Field name	Description
7:0	RSSI	RSSI value

Table 21: Received packet status byte 1 (first append byte after the data)

Bit	Field name	Description
7	CRC_OK	1: CRC for received data OK (or CRC disabled)
		0: CRC error in received data
6:0	LQI	Indicating the link quality

Table 22: Received packet status byte 2(second append byte after the data)

Note that register fields that control the packet handling features should only be altered when *CC1100* is in the IDLE state.

15.1 Data whitening

From a radio perspective, the ideal over the air data are random and DC free. This results in the smoothest power distribution over the occupied bandwidth. This also gives the regulation loops in the receiver uniform operation conditions (no data dependencies).

Real world data often contain long sequences of zeros and ones. Performance can then be improved by whitening the data before transmitting, and de-whitening in the receiver. With *CC1100*, this can be done automatically by setting PKTCTRL0.WHITE_DATA=1. All data, except the preamble and the sync word, are then XOR-ed with a 9-bit pseudo-random (PN9) sequence before being transmitted as shown in Figure 12. At the receiver end, the data are XOR-ed with the same pseudorandom sequence. This way, the whitening is reversed, and the original data appear in the receiver.

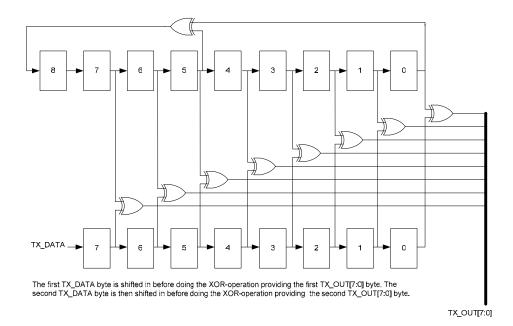


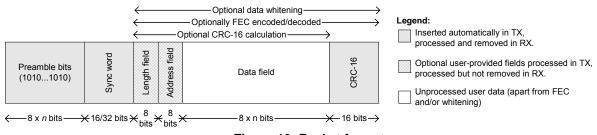
Figure 12: Data whitening in TX mode

15.2 Packet format

The format of the data packet can be configured and consists of the following items (see Figure 13):

- Preamble
- Synchronization word

- Length byte or constant programmable packet length
- Optional Address byte
- Payload
- Optional 2 byte CRC





The preamble pattern is an alternating sequence of ones and zeros (01010101...). The minimum length of the preamble is programmable. When enabling TX, the modulator will start transmitting the preamble. When the programmed number of preamble bytes has been transmitted, the modulator will send the sync word and then data from the TX FIFO if data is available. If the TX FIFO is empty, the modulator will continue to send preamble bytes until the first byte is written to the TX FIFO. The modulator will then send the sync word and then the data bytes. The

number of preamble bytes is programmed with the MDMCFG1.NUM_PREAMBLE value.

The synchronization word is a two-byte value set in the SYNC1 and SYNC0 registers. The sync word provides byte synchronization of the incoming packet. A one-byte synch word can be emulated by setting the SYNC1 value to the preamble pattern. It is also possible to emulate a 32 bit sync word by using MDMCFG2.SYNC_MODE=3 or 7. The sync word will then be repeated twice.

CC1100 supports both constant packet length protocols and variable length protocols.

Variable or fixed packet length mode can be used for packets up to 255 bytes. For longer packets, infinite packet length mode must be used.

Fixed packet length mode is selected by setting PKTCTRL0.LENGTH_CONFIG=0. The desired packet length is set by the PKTLEN register.

In variable packet length mode, PKTCTRL0.LENGTH_CONFIG=1, the packet length is configured by the first byte after the sync word. The packet length is defined as the payload data, excluding the length byte and the optional automatic CRC. The PKTLEN register is used to set the maximum packet length allowed in RX. Any packet received with a length byte with a value greater than PKTLEN will be discarded.

With PKTCTRL0.LENGTH_CONFIG=2, the packet length is set to infinite and transmission and reception will continue until turned off manually. The infinite mode can be turned off while a packet is being transmitted or received. As described in the next section, this can be used to support packet formats with different length configuration than natively supported by *CC1100*.

Note that the minimum packet length supported (excluding the optional length byte and CRC) is one byte of payload data.

15.2.1 Arbitrary length field configuration

The fixed length field can be reprogrammed during receive and transmit. This opens the possibility to have a different length field configuration than supported for variable length packets. At the start of reception, the packet length is set to a large value. The MCU reads out enough bytes to interpret the length field in the packet. Then the PKTLEN value is set according to this value. The end of packet will occur when the byte counter in the packet handler is equal to the PKTLEN register. Thus, the MCU must be able to program the correct length, before the internal counter reaches the packet length.

By utilizing the infinite packet length option, arbitrary packet length is available. At the start of the packet, the infinite mode must be active. On the TX side, the PKTLEN register is set to mod(length, 256). On the RX side the MCU reads out enough bytes to interpret the length field in the packet. and sets the PKTLEN register to mod(length, 256). When less than 256 bytes remains of the packet the MCU disables infinite packet length and activates fixed length packets. When the internal byte counter reaches the PKTLEN value, the transmission or reception ends. Automatic CRC appending/checking can be used (by setting PKTCTRL0.CRC_EN to 1).

When for example a 600-byte packet is to be transmitted, the MCU should do the following (see also Figure 14)

- Set PKTCTRL0.LENGTH_CONFIG=2 (10).
- Pre-program the PKTLEN register to mod(600,256)=88.
- Transmit at least 345 bytes, for example by filling the 64-byte TX FIFO six times (384 bytes transmitted).
- Set PKTCTRL0.LENGTH_CONFIG=0 (00).
- The transmission ends when the packet counter reaches 88. A total of 600 bytes are transmitted.

Internal byte counter in packet handler counts from 0 to 255 and then starts at 0 again

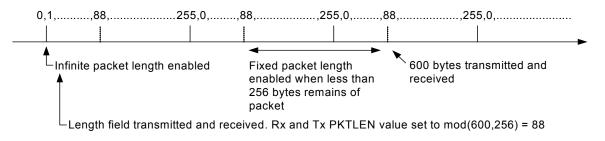


Figure 14: Arbitrary length field configuration

15.3 Packet Filtering in Receive Mode

CC1100 supports three different types of packet-filtering; address filtering, maximum length filtering and CRC filtering.

15.3.1 Address Filtering

Setting PKTCTRL1.ADR_CHK to any other value than zero enables the packet address filter. The packet handler engine will compare the destination address byte in the packet with the programmed node address in the ADDR register and the 0x00 broadcast address when PKTCTRL1.ADR CHK=10 or both 0x00 and 0xFF broadcast addresses when PKTCTRL1.ADR CHK=11. If the received address matches a valid address, the packet is received and written into the RX FIFO. If the address match fails, the packet is discarded and receive mode restarted (regardless of the MCSM1.RXOFF_MODE setting).

If the received address matches a valid address when the packet length is set to infinite *and* address filtering is enabled, 0xFF will be written into the RX FIFO followed by the address byte and then the payload data.

15.3.2 Maximum Length Filtering

In variable packet length mode the PKTLEN.PACKET_LENGTH register value is used to set the maximum allowed packet length. If the received length byte has a larger value than this, the packet is discarded and receive mode restarted (regardless of the MCSM1.RXOFF_MODE setting).

15.3.3 CRC Filtering

The filtering of a packet when CRC check fails is enabled with PKTCTRL1.CRC_AUTOFLUSH. The CRC auto flush function will flush the *entire* RX FIFO if the CRC check fails. After auto flushing the RX FIFO, the next state depends on the MCSM1.RXOFF_MODE setting.

When using the auto flush function, the maximum packet length is 63 bytes in variable packet length mode and 64 bytes in fixed packet length mode. Note that the maximum allowed packet length is reduced by two bytes when PKTCTRL1.APPEND_STATUS is enabled, to make room in the RX FIFO for the two status bytes appended at the end of the packet. Since the entire RX FIFO is flushed when the CRC check fails, the previously received packet must be read out of the FIFO

before receiving the current packet. The MCU must not read from the current packet until the CRC has been checked as OK.

15.4 Packet Handling in Transmit Mode

The payload that is to be transmitted must be written into the TX FIFO. The first byte written must be the length byte when variable packet length is enabled. The length byte has a value equal to the payload of the packet (including the optional address byte). If fixed packet length is enabled, then the first byte written to the TX FIFO is interpreted as the destination address, if this feature is enabled in the device that receives the packet.

The modulator will first send the programmed number of preamble bytes. If data is available in the TX FIFO, the modulator will send the two-byte (optionally 4-byte) sync word and then the payload in the TX FIFO. If CRC is enabled, the checksum is calculated over all the data pulled from the TX FIFO and the result is sent as two extra bytes at the end of the payload data.

If whitening is enabled, the length byte, payload data and the two CRC bytes will be whitened. This is done before the optional FEC/Interleaver stage. Whitening is enabled by setting PKTCTRL0.WHITE_DATA=1.

If FEC/Interleaving is enabled, the length byte, payload data and the two CRC bytes will be scrambled by the interleaver, and FEC encoded before being modulated.

15.5 Packet Handling in Receive Mode

In receive mode, the demodulator and packet handler will search for a valid preamble and the sync word. When found, the demodulator has obtained both bit and byte synchronism and will receive the first payload byte.

If FEC/Interleaving is enabled, the FEC decoder will start to decode the first payload byte. The interleaver will de-scramble the bits before any other processing is done to the data.

If whitening is enabled, the data will be dewhitened at this stage.

When variable packet length is enabled, the first byte is the length byte. The packet handler stores this value as the packet length and receives the number of bytes indicated by the length byte. If fixed packet length is used, the packet handler will accept the programmed number of bytes.

Next, the packet handler optionally checks the address and only continues the reception if the address matches. If automatic CRC check is enabled, the packet handler computes CRC

16 Modulation Formats

CC1100 supports amplitude, frequency and phase shift modulation formats. The desired modulation format is set in the MDMCFG2.MOD_FORMAT register.

Optionally, the data stream can be Manchester coded by the modulator and decoded by the demodulator. This option is enabled by setting MDMCFG2.MANCHESTER_EN=1. Manchester encoding cuts the effective data rate in half, and thus Manchester is not supported for 500 kbps. Manchester encoding is not supported at the same time as using the FEC/Interleaver option.

16.1 Frequency Shift Keying

FSK can optionally be shaped by a Gaussian filter with BT=1, producing a GFSK modulated signal.

The frequency deviation is programmed with the DEVIATION_M and DEVIATION_E values in the DEVIATN register. The value has an exponent/mantissa form, and the resultant deviation is given by:

$$f_{dev} = \frac{f_{xosc}}{2^{17}} \cdot (8 + DEVIATION _M) \cdot 2^{DEVIATION_E}$$

The symbol encoding is shown in Table 23.

Format	Symbol	Coding
FSK/GFSK	ʻ0'	- Deviation
	'1'	+ Deviation

Table 23: Symbol encoding for FSK/GFSK modulation

and matches it with the appended CRC checksum.

At the end of the payload, the packet handler will optionally write two extra packet status bytes (see Table 21 and Table 22) that contain CRC status, link quality indication and RSSI value.

16.2 Minimum Shift Keying

When using MSK¹, the complete transmission (preamble, sync word and payload) will be MSK modulated.

Phase shifts are performed with a constant transition time.

The fraction of a symbol period used to change the phase can be modified with the DEVIATN.DEVIATION_M setting. This is equivalent to changing the shaping of the symbol.

The MSK modulation format implemented in *CC1100* inverts the sync word and data compared to e.g. signal generators.

16.3 Amplitude Modulation

CC1100 supports two different forms of amplitude modulation: On-Off Keying (OOK) and Amplitude Shift Keying (ASK).

OOK modulation simply turns on or off the PA to modulate 1 and 0 respectively.

The ASK variant supported by the *CC1100* allows programming of the modulation depth (the difference between 1 and 0), and shaping of the pulse amplitude. Pulse shaping will produce a more bandwidth constrained output spectrum. Note that the pulse shaping feature on the *CC1100* does only support output power up to about -1dBm. The PA_TABLE settings that can be used for pulse shaping are 0x30 to 0x3F.

¹ Identical to offset QPSK with half-sine shaping (data coding may differ)

CC1100

17 Received Signal Qualifiers and Link Quality Information

CC1100 has several qualifiers that can be used to increase the likelihood that a valid sync word is detected.

17.1 Sync Word Qualifier

If sync word detection in RX is enabled in register MDMCFG2 the *CC1100* will not start filling the RX FIFO and perform the packet filtering described in Section 15.3 before a valid sync word has been detected. The sync word qualifier mode is set by MDMCFG2.SYNC_MODE and is summarized in Table 24. Carrier sense in Table 24 is described in section 17.4.

MDMCFG2.	Sync word qualifier mode	
SYNC_MODE		
000	No preamble/sync	
001	15/16 sync word bits detected	
010	16/16 sync word bits detected	
011	30/32 sync word bits detected	
100	No preamble/sync, carrier sense above threshold	
101	15/16 + carrier sense above threshold	
110	16/16 + carrier sense above threshold	
111	30/32 + carrier sense above threshold	

 Table 24: Sync word qualifier mode

17.2 Preamble Quality Threshold (PQT)

The Preamble Quality Threshold (PQT) syncword qualifier adds the requirement that the received sync word must be preceded with a preamble with a quality above the programmed threshold.

Another use of the preamble quality threshold is as a qualifier for the optional RX termination timer. See section 19.7 on page 44 for details.

The preamble quality estimator increases an internal counter by one each time a bit is received that is different from the previous bit, and decreases the counter by 4 each time a bit is received that is the same as the last bit. The counter saturates at 0 and 31. The threshold is configured with the register field PKTCTRL1.PQT. A threshold of 4·PQT for this counter is used to gate sync word detection.

By setting the value to zero, the preamble quality qualifier of the synch word is disabled.

A "Preamble Quality reached" flag can also be observed on one of the GDO pins and in the status register bit PKTSTATUS.PQT_REACHED. This flag asserts when the received signal exceeds the PQT.

17.3 RSSI

The RSSI value is an estimate of the signal power level in the chosen channel. This value is based on the current gain setting in the RX chain and the measured signal level in the channel.

In RX mode, the RSSI value can be read continuously from the RSSI status register until the demodulator detects a sync word (when sync word detection is enabled). At that point the RSSI readout value is frozen until the next time the chip enters the RX state. The RSSI value is in dB with ½dB resolution. The RSSI update rate depends on the receiver filter bandwidth (BW_{channel} defined in section 13) and AGCCTRL0.FILTER LENGTH.

$$f_{RSSI} = \frac{2 \cdot BW_{channel}}{8 \cdot 2^{FILTER - LENGTH}}$$

If PKTCTRL1.APPEND_STATUS is enabled the last RSSI value of the packet is automatically added to the first byte appended after the data.

The RSSI value read from the RSSI status register is a 2's complement number. The following procedure can be used to convert the RSSI reading to an absolute power level (RSSI_dBm).

- 1) Read the RSSI status register
- 2) Convert the reading from a hexadecimal number to a decimal number (RSSI_dec)
- 3) If RSSI_dec ≥ 128 then RSSI_dBm = (RSSI_dec 256)/2 RSSI_offset
- 4) Else if RSSI_dec < 128 then RSSI_dBm = (RSSI_dec)/2 – RSSI_offset

Table 25 gives typical values for the RSSI_offset.





Figure 15 shows typical plots of RSSI reading as a function of input power level for different

data rates.

Data rate	RSSI_offset (decimal), 433 MHz	RSSI_offset (decimal), 868 MHz
1.2 kbps 75 74		74
38.4 kbps	kbps 75 74	
250 kbps	79	78
500 kbps	79	77

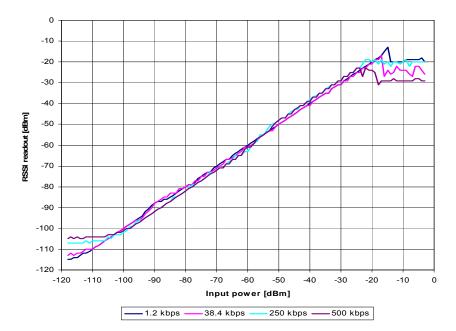


Table 25: Typical RSSI_offset values

Figure 15: Typical RSSI value vs. input power level for some typical data rates at 433 MHz

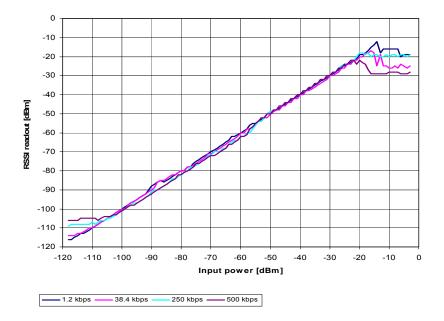


Figure 16: Typical RSSI value vs. input power level for some typical data rates at 868 MHz



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17.4 Carrier Sense (CS)

The Carrier Sense flag is used as a sync word qualifier and for CCA. The CS flag can be set based on two conditions, which can be individually adjusted:

- CS is asserted when the RSSI is above a programmable absolute threshold, and deasserted when RSSI is below the same threshold (with hysteresis).
- CS is asserted when the RSSI has increased with a programmable number of dB from one RSSI sample to the next, and de-asserted when RSSI has decreased with the same number of dB. This setting is not dependent on the absolute signal level and is thus useful to detect signals in environments with time varying noise floor.

Carrier Sense (CS) can be used as a sync word qualifier that requires the signal level to be higher than the threshold for a sync word search to be performed. The signal can also be observed on one of the GDO pins and in the status register bit PKTSTATUS.CS.

Other uses of Carrier Sense include the TX-If-CCA function (see section 17.5 on page 39) and the optional fast RX termination (see section 19.7 on page 44).

CS can be used to avoid interference from other RF sources in the ISM bands.

17.4.1 CS Absolute Threshold

The absolute threshold related to the RSSI value is given by:

 $THR_{RSSI} = MAGN _TARGET + CARRIER _SENSE _ABS _THR - GAIN_{MAX}$

The maximum possible gain can be reduced using the AGCCTRL2.MAX_LNA_GAIN and AGCCTRL2.MAX_DVGA_GAIN register fields. CARRIER_SENSE_ABS_THR is programmable in 1 dB steps from -7 dB to + 7dB.

Table 26 and Table 27 show the RSSI readout values at the CS threshold at 2.4 kbps and 250 kbps data rate respectively. The default CARRIER_SENSE_ABS_THR = 0 (0 dB) and MAGN_TARGET = 3 (33 dB) have been used.

		MAX_DVGA_GAIN[1:0]				
		00	01	10	11	
	000	-97.5	-91.5	-85.5	-79.5	
2:0]	001	-94	-88	-82.5	-76	
GAIN[2:0]	010	-90.5	-84.5	-78.5	-72.5	
	011	-88	-82.5	-76.5	-70.5	
MAX_LNA	100	-85.5	-80	-73.5	-68	
\neg	101	-84	-78	-72	-66	
MAX	110	-82	-76	-70	-64	
—	111	-79	-73.5	-67	-61	

Table 26: Typical RSSI value in dBm at CS threshold with default MAGN_TARGET at 2.4 kbps, 868 MHz

		MAX_DVGA_GAIN[1:0]				
		00	01	10	11	
	000	-90.5	-84.5	-78.5	-72.5	
2:0]	001	-88	-82	-76	-70	
	010	-84.5	-78.5	-72	-66	
٩ð'	011	-82.5	-76.5	-70	-64	
Ă	100	-80.5	-74.5	-68	-62	
\neg	101	-78	-72	-66	-60	
MAX_LNA_GAIN[2:0]	110	-76.5	-70	-64	-58	
—	111	-74.5	-68	-62	-56	

Table 27: Typical RSSI value in dBm at CS threshold with default MAGN_TARGET at 250 kbps, 868 MHz

If the threshold is set high, i.e. only strong signals are wanted, the threshold should be adjusted upwards by first reducing the MAX_LNA_GAIN value and then the MAX_DVGA_GAIN value. This will reduce power consumption in the receiver front end, since the highest gain settings are avoided.

The MAGN_TARGET setting is a compromise between blocker tolerance/selectivity and sensitivity. The value sets the desired signal level in the channel into the demodulator. Increasing this value reduces the headroom for blockers, and therefore close-in selectivity.

17.4.2 CS relative threshold

The relative threshold detects sudden changes in the measured signal level. This setting is not dependent on the absolute signal level and is thus useful to detect signals in environments with a time varying noise floor. The register field AGCCTRL1.CARRIER_SENSE_REL_THR is used to enable/disable relative CS, and to select threshold of 6 dB, 10 dB or 14 dB RSSI change.

17.5 Clear Channel Assessment (CCA)

The Clear Channel Assessment is used to indicate if the current channel is free or busy. The current CCA state is viewable on any of GDO pins.

MCSM1.CCA_MODE selects the mode to use when determining CCA.

When the STX or SFSTXON command strobe is given while *CC1100* is in the RX state, the TX state is only entered if the clear channel requirements are fulfilled. The chip will otherwise remain in RX. This feature is called TX if CCA.

Four CCA requirements can be programmed:

- Always (CCA disabled, always goes to TX)
- If RSSI is below threshold
- Unless currently receiving a packet
- Both the above (RSSI below threshold and not currently receiving a packet)

17.6 Link Quality Indicator (LQI)

The Link Quality Indicator is a metric of the current quality of the received signal. If PKTCTRL1.APPEND_STATUS is enabled, the value is automatically appended to the end of each received packet. The value can also be read from the LQI status register. The LQI is calculated over the 64 symbols following the sync word (first 8 packet bytes). LQI is best used as a relative measurement of the link quality, since the value is dependent on the modulation format.

18 Forward Error Correction with Interleaving

18.1 Forward Error Correction (FEC)

CC1100 has built in support for Forward Error Correction (FEC). To enable this option, set MDMCFG1.FEC_EN to 1. FEC is only supported mode in fixed packet length (PKTCTRL0.LENGTH CONFIG=0). FEC is employed on the data field and CRC word in order to reduce the gross bit error rate when sensitivity operating near the limit. Redundancy is added to the transmitted data in such a way that the receiver can restore the original data in the presence of some bit errors.

The use of FEC allows correct reception at a lower SNR, thus extending communication range if the receiver bandwidth remains constant. Alternatively, for a given SNR, using FEC decreases the bit error rate (BER). As the packet error rate (PER) is related to BER by:

$$PER = 1 - (1 - BER)^{packet_length}$$

a lower BER can be used to allow longer packets, or a higher percentage of packets of a given length, to be transmitted successfully. Finally, in realistic ISM radio environments, transient and time-varying phenomena will produce occasional errors even in otherwise good reception conditions. FEC will mask such errors and, combined with interleaving of the coded data, even correct relatively long periods of faulty reception (burst errors).

The FEC scheme adopted for *CC1100* is convolutional coding, in which *n* bits are generated based on *k* input bits and the *m* most recent input bits, forming a code stream able to withstand a certain number of bit errors between each coding state (the *m*-bit window).

The convolutional coder is a rate 1/2 code with a constraint length of m=4. The coder codes one input bit and produces two output bits; hence, the effective data rate is halved. I.e. to transmit the same effective datarate when using FEC, it is necessary to use twice as high over-the-air datarate. This will require a higher receiver bandwidth, and thus reduce sensitivity. In other words the improved reception by using FEC and the degraded sensitivity from a higher receiver bandwidth will be counteracting factors.

18.2 Interleaving

Data received through real radio channels will often experience burst errors due to interference and time-varying signal strengths. In order to increase the robustness to errors



spanning multiple bits, interleaving is used when FEC is enabled. After de-interleaving, a continuous span of errors in the received stream will become single errors spread apart.

CC1100 employs matrix interleaving, which is illustrated in Figure 17. The on-chip interleaving and de-interleaving buffers are 4 x 4 matrices. In the transmitter, the data bits are written into the rows of the matrix, whereas the bit sequence to be transmitted is read from the columns of the matrix and fed to the rate $\frac{1}{2}$ convolutional coder. Conversely, in the receiver, the received symbols are written into the columns of the matrix, whereas the data passed onto the convolutional decoder is read from the rows of the matrix.

When FEC and interleaving is used at least one extra byte is required for trellis termination. In addition, the amount of data transmitted over the air must be a multiple of the size of the interleaver buffer (two bytes). The packet control hardware therefore automatically inserts one or two extra bytes at the end of the packet, so that the total length of the data to be interleaved is an even number. Note that these extra bytes are invisible to the user, as they are removed before the received packet enters the RX FIFO.

When FEC and interleaving is used the minimum data payload is 2 bytes.

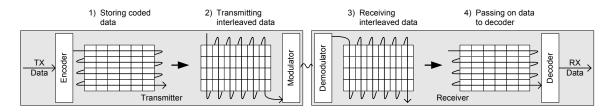


Figure 17: General principle of matrix interleaving



19 Radio Control

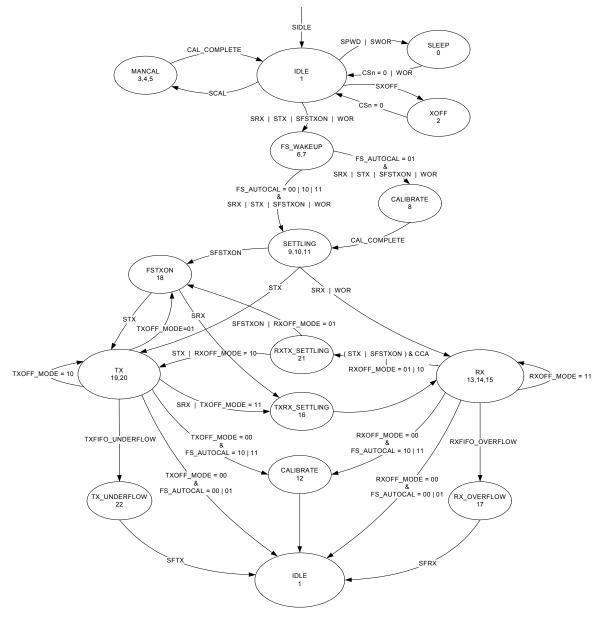


Figure 18: Complete Radio Control State Diagram

CC1100 has a built-in state machine that is used to switch between different operational states (modes). The change of state is done either by using command strobes or by internal events such as TX FIFO underflow.

A simplified state diagram, together with typical usage and current consumption, is shown in Figure 7 on page 23. The complete radio control state diagram is shown in Figure 18. The numbers refer to the state number readable in the MARCSTATE status register. This register is primarily for test purposes.

19.1 Power on start-up sequence

When the power supply is turned on, the system must be reset. This is achieved by one of the two sequences described below, i.e. Automatic power-on reset or manual reset.

After the automatic power-on reset or manual reset it is also recommended to change the signal that is output on the GDO0 pin. The default setting is to output a clock signal with a frequency of CLK_XOSC/192, but to optimize performance in TX and RX an alternative GDO

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setting should be selected from the settings found in Table 33 on page 53.

19.1.1 Automatic POR

A power-on reset circuit is included in the *CC1100*. The minimum requirements stated in Section 0 must be followed for the power-on reset to function properly. The internal power-up sequence is completed when CHIP_RDYn goes low. CHIP_RDYn is observed on the SO pin after CSn is pulled low. See Section 10.1 for more details on CHIP_RDYn.

When the *CC1100* reset is completed the chip will be in the IDLE state and the crystal oscillator running. If the chip has had sufficient time for the crystal oscillator and voltage regulator to stabilize after the power-on-reset the so pin will go low immediately after taking CSn low. If CSn is taken low before reset is completed the so pin will first go high, indicating that the crystal oscillator and voltage regulator is not stabilized, before going low as shown in Figure 19.

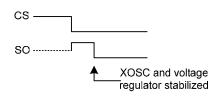


Figure 19: Power-on reset

19.1.2 Manual Reset

The other global reset possibility on *CC1100* uses the SRES command strobe. By issuing this strobe, all internal registers and states are set to the default, IDLE state. The manual power-up sequence is as follows (see Figure 20):

- Set SCLK=1 and SI=0, to avoid potential problems with pin control mode (see section 11.3 on page 29).
- Strobe CSn low / high.
- Hold CSn high for at least 40µs relative to pulling CSn low
- Pull CSn low and wait for SO to go low (CHIP_RDYn).
- Issue the SRES strobe on the SI line.

• When so goes low again, reset is complete and the chip is in the IDLE state.

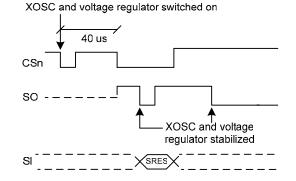


Figure 20: Power-on reset with SRES

Note that the above reset procedure is only required just after the power supply is first turned on. If the user wants to reset the *CC1100* after this, it is only necessary to issue an SRES command strobe.

19.2 Crystal Control

The crystal oscillator (XOSC) is either automatically controlled or always on, if MCSM0.XOSC_FORCE_ON is set.

In the automatic mode, the XOSC will be turned off if the SXOFF or SPWD command strobes are issued; the state machine then goes to XOFF or SLEEP respectively. This can only be done from the IDLE state. The XOSC will be turned off when CSn is released (goes high). The XOSC will be automatically turned on again when CSn goes low. The state machine will then go to the IDLE state. The SO pin on the SPI interface must be zero before the SPI interface is ready to be used; as described in Section 10.1 on page 26.

If the XOSC is forced on, the crystal will always stay on even in the SLEEP state.

Crystal oscillator start-up time depends on crystal ESR and load capacitances. The electrical specification for the crystal oscillator can be found in section 4.4 on page 14.

19.3 Voltage Regulator Control

The voltage regulator to the digital core is controlled by the radio controller. When the chip enters the SLEEP state, which is the state with the lowest current consumption, this voltage regulator is disabled. This occurs after CSn is released when a SPWD command strobe has been sent on the SPI interface. The chip is now in the SLEEP state. Setting CSn low again will turn on the regulator and crystal oscillator and make the chip enter the IDLE state.

When wake on radio is enabled, the WOR module will control the voltage regulator as described in Section 19.5.

19.4 Active Modes

CC1100 has two active modes: receive and transmit. These modes are activated directly by the MCU by using the SRX and STX command strobes, or automatically by Wake on Radio.

The frequency synthesizer must be calibrated regularly. *CC1100* has one manual calibration option (using the SCAL strobe), and three automatic calibration options, controlled by the MCSM0.FS_AUTOCAL setting:

- Calibrate when going from IDLE to either RX or TX (or FSTXON)
- Calibrate when going from either RX or TX to IDLE
- Calibrate every fourth time when going from either RX or TX to IDLE

The calibration takes a constant number of XOSC cycles (see Table 28 for timing details).

When RX is activated, the chip will remain in receive mode until a packet is successfully received or the RX termination timer expires (see Section 19.7). Note: the probability that a false sync word is detected can be reduced by using PQT, CS, maximum sync word length and sync word qualifier mode as described in Section 17. After a packet is successfully received the radio controller will then go to the state indicated by the MCSM1.RXOFF_MODE setting. The possible destinations are:

- IDLE
- FSTXON: Frequency synthesizer on and ready at the TX frequency. Activate TX with STX.
- TX: Start sending preamble
- RX: Start search for a new packet

Similarly, when TX is active the chip will remain in the TX state until the current packet has been successfully transmitted. Then the state will change as indicated by the MCSM1.TXOFF_MODE setting. The possible destinations are the same as for RX.

The MCU can manually change the state from RX to TX and vice versa by using the command strobes. If the radio controller is currently in transmit and the SRX strobe is used, the current transmission will be ended and the transition to RX will be done.

If the radio controller is in RX when the STX or SFSTXON command strobes are used, the "TX if clear channel" function will be used. If the channel is not clear, the chip will remain in RX. The MCSM1.CCA_MODE setting controls the conditions for clear channel assessment. See section 17.5 on page 39 for details.

The SIDLE command strobe can always be used to force the radio controller to go to the IDLE state.

19.5 Wake on Radio (WOR)

The optional Wake on Radio (WOR) functionality enables *CC1100* to periodically wake up from deep sleep and listen for incoming packets without MCU interaction.

When WOR is enabled, the *CC1100* will go to the SLEEP state when CSn is released after the SWOR command strobe has been sent on the SPI interface. The RC oscillator must be enabled before the WOR strobe can be used, as it is the clock source for the WOR timer. The on-chip timer will set *CC1100* into IDLE state and then RX state. After a programmable time in RX, the chip will go back to the SLEEP state, unless a packet is received. See Figure 21 and section 19.7 for details on how the timeout works.

CC1100 can be set up to signal the MCU that a packet has been received by using the GDO pins. If a packet is received, the MCSM1.RXOFF_MODE will determine the behaviour at the end of the received packet. When the MCU has read the packet, it can put the chip back into SLEEP with the SWOR strobe from the IDLE state. The FIFO will loose its contents in the SLEEP state.

The WOR timer has two events, Event 0 and Event 1. In the SLEEP state with WOR activated, reaching Event 0 will turn on the digital regulator and start the crystal oscillator. Event 1 follows Event 0 after a programmed timeout.

The time between two consecutive Event 0 is programmed with a mantissa value given by

WOREVT1.EVENT0 and WOREVT0.EVENT0, and an exponent value set by WORCTRL.WOR_RES. The equation is:

$$t_{Event0} = \frac{750}{f_{XOSC}} \cdot EVENT0 \cdot 2^{5 \cdot WOR_RES}$$

The Event 1 timeout is programmed with WORCTRL.EVENT1. Figure 21 shows the timing relationship between Event 0 timeout and Event 1 timeout.

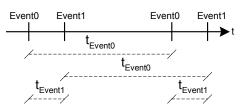


Figure 21: Event 0 and Event 1 Relationship

Refer to Application Note AN038 CC1100/CC2500 Wake on Radio for further details.

The WOR functionality has two control modes selected by the PKTCTRL1.WOR_AUTOSYNC bit. When this value is set to 0, the radio will wake up on Event 0 and enable RX on Event 1. This ensures that RX is entered at a precise time.

When PKTCTRL1.WOR_AUTOSYNC is set to 1, after Event 0 wakes up the chip, it will enter RX mode as soon as the chip is ready. When a sync word is detected, the WOR timer will be reset to the programmed Event 1 value. The timer will now be synchronized to the received packet. By programming Event 0 to the packet spacing time and Event 1 to a time large enough to wake up the chip and receive a sync word, the timer will stay selfsynchronized to the incoming packets.

19.5.1 RC oscillator and timing

The frequency of the low-power RC oscillator used for the WOR functionality varies with temperature and supply voltage. In order to keep the frequency as accurate as possible, the RC oscillator will be calibrated whenever possible, which is when the XOSC is running and the chip is not in the SLEEP state. When the power and XOSC is enabled, the clock used by the WOR timer is a divided XOSC clock. When the chip goes to the sleep state, the RC oscillator will use the last valid calibration result. The frequency of the RC oscillator is locked to the main crystal frequency divided by 750.

Description	XOSC periods	26MHz crystal
IDLE to RX, no calibration	2298	88.4µs
IDLE to RX, with calibration	~21037	809µs
IDLE to TX/FSTXON, no calibration	2298	88.4µs
IDLE to TX/FSTXON, with calibration	~21037	809µs
TX to RX switch	560	21.5µs
RX to TX switch	250	9.6µs
RX or TX to IDLE, no calibration	2	0.1µs
RX or TX to IDLE, with calibration	~18739	721µs
Manual calibration	~18739	721µs

Table 28: State transition timing

19.6 Timing

The radio controller controls most of the timing in *CC1100*, such as synthesizer calibration, PLL lock and RT/TX turnaround times. Timing from IDLE to RX and IDLE to TX is constant, dependent on the auto calibration setting. RX/TX and TX/RX turnaround times are constant. The calibration time is constant 18739 clock periods. Table 28 shows timing in crystal clock cycles for key state transitions.

Power on time and XOSC start-up times are variable, but within the limits stated in Table 7.

19.7 RX Termination Timer

CC1100 has optional functions for automatic termination of RX after a programmable time. The main use for this functionality is wake-on-radio (WOR), but it may be useful for other applications. The termination timer starts when in the RX state. The timeout is programmable with the MCSM2.RX_TIME setting. When the timer expires, the radio controller will check the condition for staying in RX; if the condition is not met, RX will terminate. After the timeout, the condition will be checked continuously.

The programmable conditions are:

- MCSM2.RX_TIME_QUAL=0: Continue receive if sync word has been found
- MCSM2.RX_TIME_QUAL=1: Continue receive if sync word has been found or preamble quality is above threshold (PQT)

If the system can expect the transmission to have started when enabling the receiver, the

MCSM2.RX_TIME_RSSI function can be used. The radio controller will then terminate RX if the first valid carrier sense sample indicates no carrier (RSSI below threshold). See Section 17.4 on page 38 for details on Carrier Sense.

For ASK/OOK modulation, lack of carrier sense is only considered valid after eight symbol periods. Thus, the MCSM2.RX_TIME_RSSI function can be used in ASK/OOK mode when the distance between "1" symbols is 8 or less.

If RX terminates due to no carrier sense when the MCSM2.RX_TIME_RSSI function is used, or if no sync word was found when using the MCSM2.RX_TIME timeout function, the chip will always go back to IDLE if WOR is disabled and back to SLEEP if WOR is enabled.

20 Data FIFO

The *CC1100* contains two 64 byte FIFOs, one for received data and one for data to be transmitted. The SPI interface is used to read from the RX FIFO and write to the TX FIFO. Section 10.5 contains details on the SPI FIFO access. The FIFO controller will detect overflow in the RX FIFO and underflow in the TX FIFO.

When writing to the TX FIFO it is the responsibility of the MCU to avoid TX FIFO overflow. A TX FIFO overflow will result in an error in the TX FIFO content.

Likewise, when reading the RX FIFO the MCU must avoid reading the RX FIFO past its empty value, since an RX FIFO underflow will result in an error in the data read out of the RX FIFO.

The chip status byte that is available on the SO pin while transferring the SPI address contains the fill grade of the RX FIFO if the address is a read operation and the fill grade of the TX FIFO if the address is a write operation. Section 10.1 on page 26 contains more details on this.

The number of bytes in the RX FIFO and TX FIFO can be read from the status registers RXBYTES.NUM_RXBYTES and TXBYTES.NUM_TXBYTES respectively. If a received data byte is written to the RX FIFO at the exact same time as the last byte in the RX FIFO is read over the SPI interface, the RX FIFO pointer is not properly updated and the last read byte is duplicated. Otherwise, the MCSM1.RXOFF_MODE setting determines the state to go to when RX ends.

Note that in wake-on-radio (WOR) mode, the WOR state is cleared in the latter case. This means that the chip will not automatically go back to SLEEP again but to IDLE, even if e.g. the address field in the packet did not match. It is therefore recommended to always wake up the microcontroller on sync word detection when using WOR mode. This can be done by selecting output signal 6 (see Table 33 on page 53) on one of the programmable GDO output pins, and programming the microcontroller to wake up on an edgetriggered interrupt from this GDO pin.

For packet lengths less than 64 bytes it is recommended to wait until the complete packet has been received before reading it out of the RX FIFO.

If the packet length is larger than 64 bytes the MCU must determine how many bytes can be read from the RX FIFO (RXBYTES.NUM_RXBYTES -1) and the following software routine can be used:

To avoid this problem one should never empty the RX FIFO before the last byte of the packet is received. The following software fix can be used:

- 1. Read RXBYTES.NUM_RXBYTES repeatedly at a rate guaranteed to be at least twice that of which RF bytes are received until the same value is returned twice; store value in *n*.
- If n < # of bytes remaining in packet, read n-1 bytes from the RX FIFO.
- 3. Repeat steps 1 and 2 until *n* = # of bytes remaining in packet.
- 4. Read the remaining bytes from the RX FIFO.

Refer to *CC1100* Errata Note for more details.

The 4-bit FIFOTHR.FIFO_THR setting is used to program threshold points in the FIFOs. Table 29 lists the 16 FIFO_THR settings and the corresponding thresholds for the RX and TX FIFOs. The threshold value is coded in opposite directions for the RX FIFO and TX FIFO. This gives equal margin to the overflow and underflow conditions when the threshold is reached.

A flag will assert when the number of bytes in the FIFO is equal to or higher than the programmed threshold. The flag is used to generate the FIFO status signals that can be viewed on the GDO pins (see Section 0 on page 52).

Figure 23 shows the number of bytes in both the RX FIFO and TX FIFO when the threshold flag toggles, in the case of FIFO_THR=13. Figure 22 shows the flag as the respective FIFO is filled above the threshold, and then drained below.

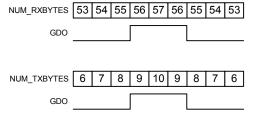
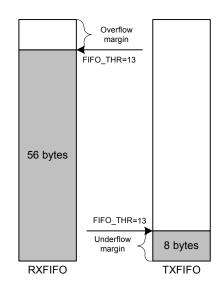
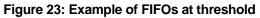


Figure 22: FIFO_THR=13 vs. number of bytes in FIFO (GDOx_CFG=0x00 in Rx and GDOx_CFG=0x02 in Tx)

FIFO_THR	Bytes in TX FIFO	Bytes in RX FIFO
0 (0000)	61	4
1 (0001)	57	8
2 (0010)	53	12
3 (0011)	49	16
4 (0100)	45	20
5 (0101)	41	24
6 (0110)	37	28
7 (0111)	33	32
8 (1000)	29	36
9 (1001)	25	40
10 (1010)	21	44
11 (1011)	17	48
12 (1100)	13	52
13 (1101)	9	56
14 (1110)	5	60
15 (1111)	1	64

Table 29: FIFO_THR settings and the corresponding FIFO thresholds





21 Frequency Programming

The frequency programming in *CC1100* is designed to minimize the programming needed in a channel-oriented system.

To set up a system with channel numbers, the desired channel spacing is programmed with the MDMCFG0.CHANSPC_M and MDMCFG1.CHANSPC_E registers. The channel spacing registers are mantissa and exponent respectively.

The base or start frequency is set by the 24 bit frequency word located in the FREQ2, FREQ1 and FREQ0 registers. This word will typically be set to the centre of the lowest channel frequency that is to be used.

The desired channel number is programmed with the 8-bit channel number register, CHANNR.CHAN, which is multiplied by the channel offset. The resultant carrier frequency is given by:

$$f_{carrier} = \frac{f_{XOSC}}{2^{16}} \cdot \left(FREQ + CHAN \cdot \left((256 + CHANSPC _M) \cdot 2^{CHANSPC _E-2} \right) \right)$$

With a 26MHz crystal the maximum channel spacing is 405kHz. To get e.g. 1MHz channel spacing one solution is to use 333 kHz channel spacing and select each third channel in CHANNR. CHAN.

The preferred IF frequency is programmed with the FSCTRL1.FREQ_IF register. The IF frequency is given by:

$$f_{IF} = \frac{f_{XOSC}}{2^{10}} \cdot FREQ_{IF}$$

22 VCO

The VCO is completely integrated on-chip.

22.1 VCO and PLL Self-Calibration

The VCO characteristics will vary with temperature and supply voltage changes, as well as the desired operating frequency. In order to ensure reliable operation, *CC1100* includes frequency synthesizer self-calibration circuitry. This calibration should be done regularly, and must be performed after turning on power and before using a new frequency (or channel). The number of XOSC cycles for completing the PLL calibration is given in Table 28 on page 44.

The calibration can be initiated automatically or manually. The synthesizer can be automatically calibrated each time the synthesizer is turned on, or each time the synthesizer is turned off. This is configured with the MCSM0.FS_AUTOCAL register setting. In manual mode, the calibration is initiated

23 Voltage Regulators

CC1100 contains several on-chip linear voltage regulators, which generate the supply voltage needed by low-voltage modules. These voltage regulators are invisible to the user, and can be viewed as integral parts of the various modules. The user must however make sure that the absolute maximum ratings and required pin voltages in Table 1 and Table 13 are not exceeded. The voltage regulator for the digital core requires one external decoupling capacitor.

Setting the CSn pin low turns on the voltage regulator to the digital core and starts the

Note that the SmartRF[®] Studio software automatically calculates the optimum FSCTRL1.FREQ_IF register setting based on channel spacing and channel filter bandwidth.

If any frequency programming register is altered when the frequency synthesizer is running, the synthesizer may give an undesired response. Hence, the frequency programming should only be updated when the radio is in the IDLE state.

when the SCAL command strobe is activated in the IDLE mode.

Note that the calibration values are maintained in sleep mode, so the calibration is still valid after waking up from sleep mode (unless supply voltage or temperature has changed significantly).

To check that the PLL is in lock the user can program register $IOCFGx.GDOx_CFG$ to 0x0A and use the lock detector output available on the GDOx pin as an interrupt for the MCU (x = 0,1 or 2). A positive transition on the GDOx pin means that the PLL is in lock. As an alternative the user can read register FSCAL1. The PLL is in lock if the register content is different from 0x3F. Refer also to the *CC1100* Errata Note. For more robust operation the source code could include a check so that the PLL is recalibrated until PLL lock is achieved if the PLL does not lock the first time.

crystal oscillator. The SO pin on the SPI interface must go low before using the serial interface (setup time is given in Table 16).

If the chip is programmed to enter power-down mode, (SPWD strobe issued), the power will be turned off after CSn goes high. The power and crystal oscillator will be turned on again when CSn goes low.

The voltage regulator output should only be used for driving the *CC1100*.

24 Output Power Programming

The RF output power level from the device has two levels of programmability, as illustrated in Figure 24. Firstly, the special PATABLE register can hold up to eight user selected output power settings. Secondly, the 3-bit FREND0.PA POWER value selects the PATABLE entry to use. This two-level functionality provides flexible PA power ramp up and ramp down at the start and end of transmission, as well as ASK modulation shaping. In each case, all the PA power settings in the PATABLE from index 0 up to the FREND0.PA_POWER value are used.

The power ramping at the start and at the end of a packet can be turned off by setting FRENDO.PA_POWER to zero and then program the desired output power to index zero in the PATABLE.

Table 30 contains recommended PATABLE settings for various output levels and frequency bands. Using PA settings from 0x61 to 0x6F is not recommended.

See section 10.6 on page 28 for PATABLE programming details.

Table 31 contains output power and current consumption for default PATABLE setting (0xC6).

PATABLE must be programmed in burst mode if you want to write to other entries than PATABLE[0].

With ASK modulation, the eight power settings are used for shaping. The modulator contains a counter that counts up when transmitting a one and down when transmitting a zero. The counter counts at a rate equal to 8 times the symbol rate. The counter saturates at FREND0.PA_POWER and 0 respectively. This counter value is used as an index for a lookup in the power table. Thus, in order to utilize the whole table, FREND0.PA_POWER should be 7 when ASK is active. The shaping of the ASK signal is dependent on the configuration of the PATABLE.

Note that the ASK shaping feature is only supported for output power levels below -1 dBm.

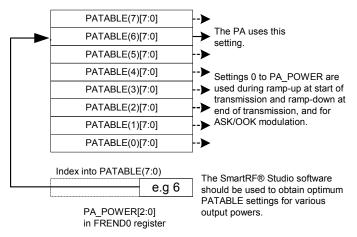


Figure 24: PA_POWER and PATABLE

Chipcon Products from Texas Instruments

	315MHz		315MHz 433MHz		433MHz	868MHz		915MHz	
Output power [dBm]	Setting	Current consumption, typ. [mA]	Setting	Current consumption, typ. [mA]	Setting	Current consumption, typ. [mA]	Setting	Current consumption, typ. [mA]	
-30	0x04	10.6	0x04	11.5	0x03	11.9	0x11	11.8	
-20	0x17	11.1	0x17	12.0	0x0D	12.4	0x0D	12.3	
-15	0x1D	11.8	0x1C	12.7	0x1C	13.0	0x1C	13.0	
-10	0x26	13.0	0x26	14.0	0x34	14.5	0x26	14.0	
-5	0x57	12.9	0x57	13.7	0x57	14.1	0x57	13.9	
0	0x60	14.8	0x60	15.5	0x8E	16.9	0x8E	16.7	
5	0x85	18.1	0x85	19.0	0x85	20.0	0x83	19.3	
7	0xCB	22.1	0xC8	24.2	0xCC	25.8	0xC9	25.8	
10	0xC2	27.0	0xC0	28.9	0xC3	30.7	0xC0	32.3	

Table 30: Optimum PATABLE settings for various output power levels and frequency bands

	315MHz		433MHz		868MHz		915MHz	
Default power setting	Output power [dBm]	Current consumption, typ. [mA]						
0xC6	8.7	24.5	7.9	25.2	8.9	28.3	7.9	26.8

Table 31: Output power and current consumption for default PATABLE setting

25 Selectivity

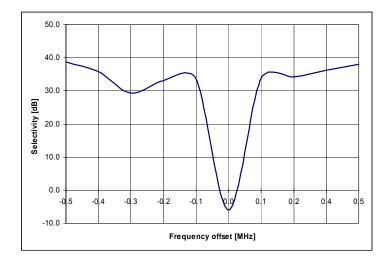


Figure 25: Typical selectivity at 1.2 kbps data rate, 868 MHz, FSK, 5.2 kHz deviation. IF frequency is 152.3 kHz and the digital channel filter bandwidth is 58 kHz

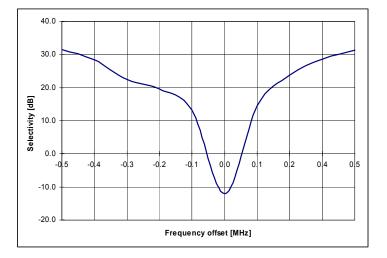


Figure 26: Typical selectivity at 38.4 kbps data rate, 868 MHz, FSK, 20 kHz deviation. IF frequency is 152.3 kHz and the digital channel filter bandwidth is 100 kHz

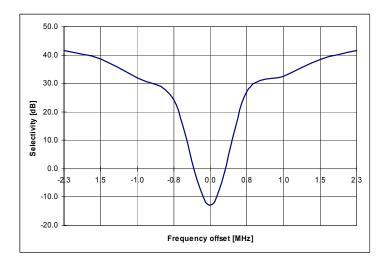


Figure 27: Typical selectivity at 250 kbps data rate, 868 MHz, MSK. IF frequency is 254 kHz and the digital channel filter bandwidth is 540 kHz



CC1100

26 Crystal Oscillator

A crystal in the frequency range 26-27 MHz must be connected between the XOSC_Q1 and XOSC_Q2 pins. The oscillator is designed for parallel mode operation of the crystal. In addition, loading capacitors (C81 and C101) for the crystal are required. The loading capacitor values depend on the total load capacitance, C_L , specified for the crystal. The total load capacitance seen between the crystal terminals should equal C_L for the crystal to oscillate at the specified frequency.

$$C_{L} = \frac{1}{\frac{1}{C_{81}} + \frac{1}{C_{101}}} + C_{parasitic}$$

The parasitic capacitance is constituted by pin input capacitance and PCB stray capacitance. Total parasitic capacitance is typically 2.5 pF. The crystal oscillator circuit is shown in Figure 28. Typical component values for different values of C_{L} are given in Table 32.

The crystal oscillator is amplitude regulated. This means that a high current is used to start up the oscillations. When the amplitude builds up, the current is reduced to what is necessary to maintain approximately 0.4 Vpp signal swing. This ensures a fast start-up, and keeps the drive level to a minimum. The ESR of the crystal should be within the specification in order to ensure a reliable start-up (see section 4.4 on page 14).

The initial tolerance, temperature drift, aging and load pulling should be carefully specified in order to meet the required frequency accuracy in a certain application.

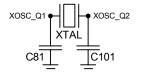


Figure 28: Crystal oscillator circuit

Component	C _L = 10 pF	C∟=13 pF	C∟=16 pF
C81	15 pF	22 pF	27 pF
C101	15 pF	22 pF	27 pF

Table 32: Crysta	l oscillator	component values
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26.1 Reference signal

The chip can alternatively be operated with a reference signal from 26 to 27MHz instead of a crystal. This input clock can either be a full-swing digital signal (0 V to VDD) or a sine wave of maximum 1 V peak-peak amplitude. The reference signal must be connected to the XOSC_Q1 input. When using a sine wave the

signal must be connected using a serial capacitor, when using a full-swing digital signal the signal this capacitor can be omitted. The XOSC_Q2 line must be left un-connected, and C81 and C101 should be omitted when using a reference signal.

27 External RF Match

The balanced RF input and output of *CC1100* share two common pins and are designed for a simple, low-cost matching and balun network on the printed circuit board. The receive- and

transmit switching at the *CC1100* front-end is controlled by a dedicated on-chip function, eliminating the need for an external RX/TX-switch.



A few passive external components combined with the internal RX/TX switch/termination circuitry ensures match in both RX and TX mode.

Although *CC1100* has a balanced RF input/output, the chip can be connected to a single-ended antenna with few external low cost capacitors and inductors.

The passive matching/filtering network connected to *CC1100* should have the following differential impedance as seen from the RF-port (RF_P and RF_N) towards the antenna:

 $Z_{out 315 MHz}$ = 122 + j31 Ω $Z_{out 433 MHz}$ = 116 + j41 Ω $Z_{out 868 MHz}$ = 86.5 + j43 Ω

To ensure optimal matching of the CC1100 differential output it is recommended to follow the CC1100EM reference designs as closely as possible. Gerber files for the reference designs are available for download from the TI and Chipcon websites.

28 General Purpose / Test Output Control Pins

The three digital output pins GDO0, GDO1 and GDO2 are general control pins configured with IOCFG0.GDO0_CFG, IOCFG1.GDO1_CFG and IOCFG2.GDO3_CFG respectively. Table 33 shows the different signals that can be monitored on the GDO pins. These signals can be used as an interrupt to the MCU. GDO1 is the same pin as the SO pin on the SPI interface, thus the output programmed on this pin will only be valid when CSn is high. The default value for GDO1 is 3-stated, which is useful when the SPI interface is shared with other devices.

The default value for GDO0 is a 135-146 kHz clock output (XOSC frequency divided by 192). Since the XOSC is turned on at power-on-reset, this can be used to clock the MCU in systems with only one crystal. When the MCU is up and running, it can change the clock frequency by writing to IOCFG0.GDO0_CFG.

An on-chip analog temperature sensor is enabled by writing the value 128 (0x80h) to the IOCFG0.GDO0_CFG register. The voltage on the GDO0 pin is then proportional to temperature. See section 4.7 on page 16 for temperature sensor specifications.

CC1100

GDO0_CF	G[5:0]
GDO1_CF	G[5:0] Description
0 (0x00)	Associated to the RX FIFO: Asserts when RX FIFO is filled at or above RXFIFO_THR. De-asserts when RX FIFO is
. ,	drained below RXFIFO_THR. Associated to the RX FIFO: Asserts when RX FIFO is filled at or above RXFIFO_THR or the end of packet is reached.
1 (0x01)	De-asserts when RX FIFO is empty.
2 (0x02)	Associated to the TX FIFO: Asserts when the TX FIFO is filled at or above TXFIFO_THR. De-asserts when the TX FIFO is below TXFIFO_THR.
3 (0x03)	Associated to the TX FIFO: Asserts when TX FIFO is full. De-asserts when the TX FIFO is drained below
4 (0x04)	TXFIFO_THR. Asserts when the RX FIFO has overflowed. De-asserts when the FIFO has been flushed.
5 (0x05)	Asserts when the TX FIFO has underflowed. De-asserts when the FIFO is flushed. Asserts when sync word has been sent / received, and de-asserts at the end of the packet. In RX, the pin will de-assert
6 (0x06)	when the optional address check fails or the RX FIFO overflows. In TX the pin will de-assert if the TX FIFO underflows.
7 (0x07) 8 (0x08)	Asserts when a packet has been received with OK CRC. De-asserts when the first byte is read from the RX FIFO. Preamble Quality Reached. Asserts when the PQI is above the programmed PQT value.
9 (0x09)	Clear channel assessment. High when RSSI level is below threshold (dependent on the current CCA_MODE setting)
10 (0x0A)	Lock detector output. The PLL is in lock if the lock detector output has a positive transition or is constantly logic high. To check for PLL lock the lock detector output should be used as an interrupt for the MCU.
11 (0x0B)	Serial Clock. Synchronous to the data in synchronous serial mode.
	Data is set up on the falling edge and is read on the rising edge of SERIAL_CLK when GDOx_INV=0. Serial Synchronous Data Output. Used for synchronous serial mode. The MCU must read DO on the rising edge of
12 (0x0C)	SERIAL_CLK when GDOx_INV=0. Data is set up on the falling edge by <i>CC1100</i> .
13 (0x0D)	Serial transparent Data Output. Used for asynchronous serial mode.
14 (0x0E) 15 (0x0F)	Carrier sense. High if RSSI level is above threshold. CRC OK. The last CRC comparison matched. Cleared when entering/restarting RX mode.
16 (0x10)	Reserved – used for test.
17 (0x11)	Reserved – used for test.
18 (0x12) 19 (0x13)	Reserved – used for test. Reserved – used for test.
20 (0x14)	Reserved – used for test.
21 (0x15)	Reserved – used for test.
22 (0x16)	RX_HARD_DATA[1]. Can be used together with RX_SYMBOL_TICK for alternative serial RX output.
23 (0x17)	RX_HARD_DATA[0]. Can be used together with RX_SYMBOL_TICK for alternative serial RX output.
24 (0x18)	Reserved – used for test.
25 (0x19) 26 (0x1A)	Reserved – used for test. Reserved – used for test.
, ,	PA_PD. Note: PA_PD will have the same signal level in SLEEP and TX states. To control an external PA or RX/TX
27 (0x1B)	switch in applications where the SLEEP state is used it is recommended to use address 47 (0x2F).
28 (0x1C)	LNA_PD. Note: LNA_PD will have the same signal level in SLEEP and RX states. To control an external LNA or RX/TX switch in applications where the SLEEP state is used it is recommended to use address 47 (0x2F).
29 (0x1D)	RX_SYMBOL_TICK. Can be used together with RX_HARD_DATA for alternative serial RX output.
30 (0x1E) 31 (0x1F)	Reserved – used for test.
32 (0x1F)	Reserved – used for test. Reserved – used for test.
33 (0x21)	Reserved – used for test.
34 (0x22)	Reserved – used for test.
35 (0x23)	Reserved – used for test.
36 (0x24)	WOR_EVNT0
37 (0x25) 38 (0x26)	WOR_EVNT1 Reserved – used for test.
38 (0x26) 39 (0x27)	Reserved – used for test.
40 (0x28)	Reserved – used for test.
41 (0x29)	CHIP_RDY
42 (0x2A)	Reserved – used for test.
43 (0x2B) 44 (0x2C)	XOSC_STABLE Reserved – used for test.
45 (0x2D)	GD00_Z_EN_N. When this output is 0, GD00 is configured as input (for serial TX data).
46 (0x2E)	High impedance (3-state)
47 (0x2F)	HW to 0 (HW1 achieved with _INV signal). Can be used to control an external LNA/PA or RX/TX switch.
48 (0x30)	Reserved – used for test. Reserved – used for test.
49 (0x31) 50 (0x32)	Reserved – used for test. Reserved – used for test.
51 (0x33)	Reserved – used for test.
52 (0x34)	Reserved – used for test.
53 (0x35)	Reserved – used for test.
54 (0x36) 55 (0x37)	Reserved – used for test. Reserved – used for test.
55 (0x37) 56 (0x38)	Reserved – used for test. Reserved – used for test.
57 (0x39)	Reserved – used for test.
58 (0x3A)	Reserved – used for test.
59 (0x3B)	Reserved – used for test.
60 (0x3C) 61 (0x3D)	Reserved – used for test. Reserved – used for test.
62 (0x3D)	Reserved – used for test.
63 (0x3F)	CLK XOSC/192

Table 33: GDOx signal selection (x = 0, 1 or 2)

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29 Asynchronous and Synchronous Serial Operation

Several features and modes of operation have been included in the *CC1100* to provide backward compatibility with previous Chipcon products and other existing RF communication systems. For new systems, it is recommended to use the built-in packet handling features, as they can give more robust communication, significantly offload the microcontroller and simplify software development.

29.1 Asynchronous operation

For backward compatibility with systems already using the asynchronous data transfer from other Chipcon products, asynchronous transfer is also included in *CC1100*. When asynchronous transfer is enabled, several of the support mechanisms for the MCU that are included in *CC1100* will be disabled, such as packet handling hardware, buffering in the FIFO and so on. The asynchronous transfer mode does not allow the use of the data whitener, interleaver and FEC.

Only FSK, GFSK and ASK/OOK are supported for asynchronous transfer.

Setting PKTCTRL0.PKT_FORMAT to 3 enables asynchronous transparent (serial) mode.

In TX, the GDO0 pin is used for data input (TX data). Data output can be GDO0, GDO1 or GDO2.

The MCU must control start and stop of transmit and receive with the STX, SRX and SIDLE strobes.

The *CC1100* modulator samples the level of the asynchronous input 8 times faster than the programmed data rate. The timing requirement

for the asynchronous stream is that the error in the bit period must be less than one eighth of the programmed data rate.

29.2 Synchronous serial operation

Setting PKTCTRL0.PKT FORMAT to 1 enables synchronous serial operation mode. In this operation mode the data must be NRZ encoded (MDMCFG2.MANCHESTER EN=0). In the synchronous serial operation mode, data is transferred on a two wire serial interface. The CC1100 provides a clock that is used to set up new data on the data input line or sample data on the data output line. Data input (TX data) is the GDO0 pin. This pin will automatically be configured as an input when TX is active. The data output pin can be any of the GDO pins; this is set by the IOCFG0.GDO0_CFG, IOCFG1.GD01_CFG and IOCFG2.GD02_CFG fields.

Preamble and sync word insertion/detection may or may not be active, dependent on the sync mode set by the MDMCFG2.SYNC_MODE. If preamble and sync word is disabled, all other packet handler features and FEC should also be disabled. The MCU must then handle preamble and sync word insertion and detection in software. If preamble and sync word insertion/detection is left on, all packet handling features and FEC can be used. One exception is that the address filtering feature is unavailable in synchronous mode.

When using the packet handling features in synchronous mode, the *CC1100* will insert and detect the preamble and sync word and the MCU will only provide/get the data payload. This is equivalent to the recommended FIFO operation mode.

30 System considerations and Guidelines

30.1 SRD Regulations

International regulations and national laws regulate the use of radio receivers and transmitters. Short Range Devices (SRDs) for license free operation below 1 GHz are usually operated in the 433 MHz, 868 MHz or 915 MHz frequency bands. The *CC1100* is specifically designed for such use with its 300-348 MHz, 400-464 MHz and 800-928 MHz operating ranges. The most important regulations when using the *CC1100* in the 433 MHz, 868 MHz or 915 MHz frequency bands are EN 300 220 (Europe), FCC CFR47 part 15 (USA). A summary of the most important aspects of these regulations can be found in Application Note *AN001 SRD regulations for licence free transceiver operation*, available from the TI and Chipcon websites.

Please note that compliance with regulations is dependent on complete system performance. It is the customer's responsibility to ensure that the system complies with regulations.

30.2 Frequency Hopping and Multi-Channel Systems

The 433 MHz, 868 MHz or 915 MHz bands are shared by many systems both in industrial, office and home environments. It is therefore recommended to use frequency hopping spread spectrum (FHSS) or a multi-channel protocol because the frequency diversity makes the system more robust with respect to interference from other systems operating in the same frequency band. FHSS also combats multipath fading.

CC1100 is highly suited for FHSS or multichannel systems due to its agile frequency synthesizer and effective communication interface. Using the packet handling support and data buffering is also beneficial in such systems as these features will significantly offload the host controller.

Charge pump current, VCO current and VCO capacitance array calibration data is required for each frequency when implementing frequency hopping for *CC1100*. There are 2 ways of obtaining the calibration data from the chip:

1) Frequency hopping with calibration for each hop. The PLL calibration time is approximately 720 μ s.

2) Fast frequency hopping without calibration for each hop can be done by calibrating each frequency at startup and saving the resulting FSCAL3, FSCAL2 and FSCAL1 register values in MCU memory.

Note that the calibrations should be carried out without the automatic selection of high/low frequency settings for the VCO, i.e. the selection should be done manually. The manual selection is done by writing a zero to TEST0 [1] to disable the automatic selection, and writing a zero or one to FSCAL2 [5] for selecting high or low VCO setting respectively. The FSCAL2 [5] setting to use for a given frequency range is calculated automatically by SmartRF Studio.

It must be noted that the TEST0 register content is not retained in POWER DOWN state, and thus it is necessary to write to this register as described above when returning from the POWER DOWN state and initiating calibrations.

Between each frequency hop, the calibration process can then be replaced by writing the FSCAL3, FSCAL2 and FSCAL1 register values corresponding to the next RF frequency. The PLL turn on time is approximately 90 µs.

30.3 Wideband Modulation not using Spread Spectrum

Digital modulation systems under FFC part 15.247 includes FSK and GFSK modulation. A maximum peak output power of 1W (+30 dBm) is allowed if the 6 dB bandwidth of the modulated signal exceeds 500 kHz. In addition, the peak power spectral density conducted to the antenna shall not be greater than +8 dBm in any 3 kHz band.

Operating at high data rates and frequency separation the *CC1100* is suited for systems targeting compliance with digital modulation system as defined by FFC part 15.247. An external power amplifier is needed to increase the output above +10 dBm.

30.4 Data Burst Transmissions

The high maximum data rate of *CC1100* opens up for burst transmissions. A low average data rate link (e.g. 10 kbps), can be realized using a higher over-the-air data rate. Buffering the data and transmitting in bursts at high data rate (e.g. 500 kbps) will reduce the time in active mode, and hence also reduce the average current consumption significantly. Reducing the time in active mode will reduce the likelihood of collisions with other systems in the same frequency range.

30.5 Continuous Transmissions

In data streaming applications the *CC1100* opens up for continuous transmissions at 500 kbps effective data rate. As the modulation is done with an I/Q up-converter with LO I/Q-signals coming from a closed loop PLL, there is no limitation in the length of a transmission. (Open loop modulation used in some transceivers often prevents this kind of continuous data streaming and reduces the effective data rate.)

30.6 Crystal Drift Compensation

The *CC1100* has a very fine frequency resolution (see Table 9). This feature can be

used to compensate for frequency offset and drift.

The frequency offset between an 'external' transmitter and the receiver is measured in the *CC1100* and can be read back from the FREQEST status register as described in Section 14.1. The measured frequency offset can be used to calibrate the frequency using the 'external' transmitter as the reference. That is, the received signal of the device will match the receiver's channel filter better. In the same way the centre frequency of the transmitted signal will match the 'external' transmitter's signal.

30.7 Spectrum Efficient Modulation

CC1100 also has the possibility to use Gaussian shaped FSK (GFSK). This spectrum-shaping feature improves adjacent channel power (ACP) and occupied bandwidth. In 'true' FSK systems with abrupt frequency shifting, the spectrum is inherently broad. By making the frequency shift 'softer', the spectrum can be made significantly narrower. Thus, higher data rates can be transmitted in the same bandwidth using GFSK.

30.8 Low Cost Systems

As the *CC1100* provides 500 kbps multi-channel performance without any external filters, a very low cost system can be made.

A HC-49 type SMD crystal is used in the CC1100EM reference design. Note that the crystal package strongly influences the price. In a size constrained PCB design a smaller, but more expensive, crystal may be used.

30.9 Battery Operated Systems

In low power applications, the SLEEP state with the crystal oscillator core switched off should be used when the *CC1100* is not active. It is possible to leave the crystal oscillator core running in the SLEEP state if start-up time is critical.

The WOR functionality should be used in low power applications.

30.10 Increasing Output Power

In some applications it may be necessary to extend the link range. Adding an external power amplifier is the most effective way of doing this.

The power amplifier should be inserted between the antenna and the balun, and two T/R switches are needed to disconnect the PA in RX mode. See Figure 29.

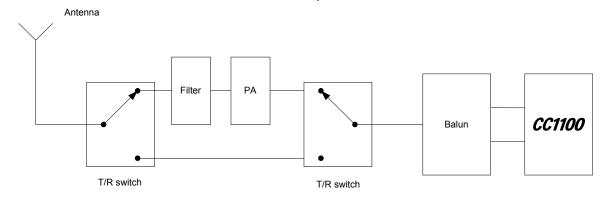


Figure 29. Block diagram of *CC1100* usage with external power amplifier

31 Configuration Registers

The configuration of *CC1100* is done by programming 8-bit registers. The configuration data based on selected system parameters are most easily found by using the SmartRF[®]

Studio software. Complete descriptions of the registers are given in the following tables. After chip reset, all the registers have default values as shown in the tables.

There are 14 Command Strobe Registers, listed in Table 34. Accessing these registers will initiate the change of an internal state or mode. There are 47 normal 8-bit Configuration Registers, listed in Table 35. Many of these registers are for test purposes only, and need not be written for normal operation of *CC1100*.

There are also 12 Status registers, which are listed in Table 36. These registers, which are read-only, contain information about the status of *CC1100*.

The two FIFOs are accessed through one 8-bit register. Write operations write to the TX FIFO, while read operations read from the RX FIFO.

During the address transfer and while writing to a register or the TX FIFO, a status byte is returned. This status byte is described in Table 17 on page 26.

Table 37 summarizes the SPI address space. The address to use is given by adding the base address to the left and the burst and read/write bits on the top. Note that the burst bit has different meaning for base addresses above and below 0x2F.

Address	Strobe Name	Description
0x30	SRES	Reset chip.
0x31	SFSTXON	Enable and calibrate frequency synthesizer (if MCSM0 . FS_AUTOCAL=1). If in RX (with CCA): Go to a wait state where only the synthesizer is running (for quick RX / TX turnaround).
0x32	SXOFF	Turn off crystal oscillator.
0x33	SCAL	Calibrate frequency synthesizer and turn it off (enables quick start). SCAL can be strobed from IDLE mode without setting manual calibration mode (MCSM0.FS_AUTOCAL=0)
0x34	SRX	Enable RX. Perform calibration first if coming from IDLE and MCSM0 . FS_AUTOCAL=1.
0x35	STX	In IDLE state: Enable TX. Perform calibration first if MCSM0 . FS_AUTOCAL=1. If in RX state and CCA is enabled: Only go to TX if channel is clear.
0x36	SIDLE	Exit RX / TX, turn off frequency synthesizer and exit Wake-On-Radio mode if applicable.
0x38	SWOR	Start automatic RX polling sequence (Wake-on-Radio) as described in section 19.5.
0x39	SPWD	Enter power down mode when CSn goes high.
0x3A	SFRX	Flush the RX FIFO buffer. Only issue SFRX in the IDLE, TXFIFO_UNDERFLOW or RXFIFO_OVERFLOW states.
0x3B	SFTX	Flush the TX FIFO buffer. Only issue SFTX in the IDLE, TXFIFO_UNDERFLOW or RXFIFO_OVERFLOW states.
0x3C	SWORRST	Reset real time clock.
0x3D	SNOP	No operation. May be used to pad strobe commands to two bytes for simpler software.

Table 34: Command Strobes

Address	Register	Description	Preserved in SLEEP state	Details on page number
0x00	IOCFG2	GDO2 output pin configuration	Yes	61
0x01	IOCFG1	GDO1 output pin configuration	Yes	61
0x02	IOCFG0	GDO0 output pin configuration	Yes	61
0x03	FIFOTHR	RX FIFO and TX FIFO thresholds	Yes	62
0x04	SYNC1	Sync word, high byte	Yes	62
0x05	SYNC0	Sync word, low byte	Yes	62
0x06	PKTLEN	Packet length	Yes	62
0x07	PKTCTRL1	Packet automation control	Yes	63
0x08	PKTCTRL0	Packet automation control	Yes	64
0x09	ADDR	Device address	Yes	64
0x0A	CHANNR	Channel number	Yes	64
0x0B	FSCTRL1	Frequency synthesizer control	Yes	65
0x0C	FSCTRL0	Frequency synthesizer control	Yes	65
0x0D	FREQ2	Frequency control word, high byte	Yes	65
0x0E	FREQ1	Frequency control word, middle byte	Yes	66
0x0F	FREQ0	Frequency control word, low byte	Yes	66
0x10	MDMCFG4	Modem configuration	Yes	66
0x11	MDMCFG3	Modem configuration	Yes	66
0x12	MDMCFG2	Modem configuration	Yes	67
0x13	MDMCFG1	Modem configuration	Yes	68
0x14	MDMCFG0	Modem configuration	Yes	68
0x15	DEVIATN	Modem deviation setting	Yes	69
0x16	MCSM2	Main Radio Control State Machine configuration	Yes	70
0x17	MCSM1	Main Radio Control State Machine configuration	Yes	71
0x18	MCSM0	Main Radio Control State Machine configuration	Yes	72
0x19	FOCCFG	Frequency Offset Compensation configuration	Yes	73
0x1A	BSCFG	Bit Synchronization configuration	Yes	74
0x1B	AGCTRL2	AGC control	Yes	75
0x1C	AGCTRL1	AGC control	Yes	76
0x1D	AGCTRL0	AGC control	Yes	77
0x1E	WOREVT1	High byte Event 0 timeout	Yes	77
0x1F	WOREVT0	Low byte Event 0 timeout	Yes	78
0x20	WORCTRL	Wake On Radio control	Yes	78
0x21	FREND1	Front end RX configuration	Yes	78
0x22	FREND0	Front end TX configuration	Yes	79
0x23	FSCAL3	Frequency synthesizer calibration	Yes	79
0x24	FSCAL2	Frequency synthesizer calibration	Yes	79
0x25	FSCAL1	Frequency synthesizer calibration	Yes	79
0x26	FSCAL0	Frequency synthesizer calibration	Yes	80
0x27	RCCTRL1	RC oscillator configuration	Yes	80
0x28	RCCTRL0	RC oscillator configuration	Yes	80
0x29	FSTEST	Frequency synthesizer calibration control	No	80
0x2A	PTEST	Production test	No	80
0x2B	AGCTEST	AGC test	No	80
0x2C	TEST2	Various test settings	No	80
0x2D	TEST1	Various test settings	No	81
0x2E	TEST0	Various test settings	No	81

 Table 35: Configuration Registers Overview

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Address	Register	Description	Details on page number
0x30 (0xF0)	PARTNUM	Part number for <i>CC1100</i>	81
0x31 (0xF1)	VERSION	Current version number	81
0x32 (0xF2)	FREQEST	Frequency Offset Estimate	81
0x33 (0xF3)	LQI	Demodulator estimate for Link Quality	81
0x34 (0xF4)	RSSI	Received signal strength indication	81
0x35 (0xF5)	MARCSTATE	Control state machine state	82
0x36 (0xF6)	WORTIME1	High byte of WOR timer	82
0x37 (0xF7)	WORTIME0	Low byte of WOR timer	82
0x38 (0xF8)	PKTSTATUS	Current GDOx status and packet status	83
0x39 (0xF9)	VCO_VC_DAC	Current setting from PLL calibration module	83
0x3A (0xFA)	TXBYTES	Underflow and number of bytes in the TX FIFO	83
0x3B (0xFB)	RXBYTES	Overflow and number of bytes in the RX FIFO	83

Table 36: Status Registers Overview

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ĺ	Wr	ite	Re								
	Single byte	Burst	Single byte	Burst							
	+0x00	+0x40	+0x80	+0xC0	ļ,						
0x00 0x01		IOC IOC									
0x01 0x02		IOC									
0x03	FIFOTHR										
0x04	SYNC1										
0x05		SYN									
0x06 0x07		PKT PKTC									
0x08		PKTC									
0x09		AD	DR								
0x0A		CHA									
0x0B 0x0C		FSC ⁻ FSC ⁻									
0x0C 0x0D		FRE									
0x0E		FRE			٩						
0x0F		FRE			sib						
0x10		MDM			sod						
0x11 0x12		MDM(MDM(SS						
0x12 0x13		MDM			e c c e						
0x14		MDM	CFG0		it ac						
0x15		DEV			R/W configuration registers, burst access possible						
0x16 0x17		MCS MCS			s, b						
0x17 0x18		MCS			ters						
0x19		FOC			egis						
0x1A		BSC			n re						
0x1B		AGCC			ation						
0x1C 0x1D		AGCC AGCC			Jura						
0x1E		WOR			nfiç						
0x1F		WOR	EVT0		8						
0x20		WOR			\sim						
0x21		FRE			ĽĽ.						
0x22 0x23		FRE FSC									
0x24		FSC									
0x25		FSC									
0x26		FSC									
0x27 0x28		RCC ⁻ RCC ⁻	· · · - ·								
0x20 0x29		FST									
0x2A		PTE									
0x2B		AGC									
0x2C 0x2D		TES									
0x2D 0x2E		TES									
0x2E											
0x30	SRES		SRES	PARTNUM							
0x31 0x32	SFSTXON SXOFF		SFSTXON SXOFF	VERSION FREQEST	รร						
0x32 0x33	SCAL		SCAL	LQI	gist(stel						
0x34	SRX		SRX	RSSI	reg egi:						
0x35	STX		STX	MARCSTATE	tus te r						
0x36	SIDLE		SIDLE	WORTIME1	by						
0x37 0x38	SWOR		SWOR	WORTIME0 PKTSTATUS	ss, (ulti						
0x38 0x39	SPWD		SPWD	VCO_VC_DAC	d m						
0x3A	SFRX		SFRX	TXBYTES	Stroanc						
0x3B	SFTX		SFTX	RXBYTES	br V						
0x3C 0x3D	SWORRST SNOP		SWORRST SNOP		n a						
0x3D 0x3E	PATABLE	PATABLE	PATABLE	PATABLE	Command Strobes, Status registers (read only) and multi byte registers						
0x3F	TX FIFO	TX FIFO	RX FIFO	RX FIFO	0 E						

Table 37: SPI Address Space

Chipcon Products from Texas Instruments

31.1 Configuration Register Details - Registers with preserved values in sleep state

Bit	Field Name	Reset	R/W	Description
7	Reserved		R0	
6	GDO2_INV	0	R/W	Invert output, i.e. select active low (1) / high (0)
5:0	GDO2_CFG[5:0]	41 (0x29)	R/W	Default is CHP_RDY_N (See Table 33 on page 53).

0x00: IOCFG2 - GDO2 output pin configuration

0x01: IOCFG1 – GDO1 output pin configuration

Bit	Field Name	Reset	R/W	Description
7	GDO_DS	0	R/W	Set high (1) or low (0) output drive strength on the GDO pins.
6	GDO1_INV	0	R/W	Invert output, i.e. select active low (1) / high (0)
5:0	GD01_CFG[5:0]	46 (0x2E)	R/W	Default is 3-state (See Table 33 on page 53)

0x02: IOCFG0 – GDO0 output pin configuration

Bit	Field Name	Reset	R/W	Description
7	TEMP_SENSOR_	0	R/W	Enable analog temperature sensor. Write 0 in all other register bits when using temperature sensor.
	ENABLE			
6	GDO0_INV	0	R/W	Invert output, i.e. select active low (1) / high (0)
5:0	GDO0_CFG[5:0]	63 (0x3F)	R/W	Default is CLK_XOSC/192 (See Table 33 on page 53).
				It is recommended to disable the clock output in initialization, in order to optimize RF performance.



Bit	Field Name	Reset	R/W	Description			
7:4	Reserved	0	R/W	Write 0 for compatibility with possible future extensions		le future extensions	
3:0	FIFO_THR[3:0]	7 (0111)	R/W	is exceeded v		nd RX FIFO. The threshold tes in the FIFO is equal to c	
				Setting	Bytes in TX FIFO	Bytes in RX FIFO	
				0 (0000)	61	4	
				1 (0001)	57	8	
				2 (0010)	53	12	
				3 (0011)	49	16	
				4 (0100)	45	20	
				5 (0101)	41	24	
				6 (0110)	37	28	
				7 (0111)	33	32	
				8 (1000)	29	36	
				9 (1001)	25	40	
				10 (1010)	21	44	
				11 (1011)	17	48	
				12 (1100)	13	52	
				13 (1101)	9	56	
				14 (1110)	5	60	
				15 (1111)	1	64	

0x03: FIFOTHR – RX FIFO and TX FIFO thresholds

0x04: SYNC1 – Sync word, high byte

Bit	Field Name	Reset	R/W	Description
7:0	SYNC[15:8]	211 (0xD3)	R/W	8 MSB of 16-bit sync word

0x05: SYNC0 - Sync word, low byte

Bit	Field Name	Reset	R/W	Description
7:0	SYNC[7:0]	145 (0x91)	R/W	8 LSB of 16-bit sync word

0x06: PKTLEN – Packet length

Bit	Field Name	Reset	R/W	Description
7:0	PACKET_LENGTH	255 (0xFF)	R/W	Indicates the packet length when fixed length packets are enabled. If variable length packets are used, this value indicates the maximum length packets allowed.

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Bit	Field Name	Reset	R/W	Descriptio	on
7:5	PQT[2:0]	0 (000)	R/W	estimator i received th counter by last bit. Th	quality estimator threshold. The preamble quality ncreases an internal counter by one each time a bit is hat is different from the previous bit, and decreases the 4 each time a bit is received that is the same as the e counter saturates at 0 and 31. d of 4 PQT for this counter is used to gate sync word
					When PQT=0 a sync word is always accepted.
4	WOR_AUTOSYNC	0	R/W	radio mode	ally synchronize timer to received packet in wake on e. When enabled the timer will automatically reset the r when a sync word is detected.
3	CRC_AUTOFLUSH	0	R/W	requires th	tomatic flush of RX FIFO when CRC in not OK. This at only one packet is in the RXIFIFO and that packet mited to the RX FIFO size.
2	APPEND_STATUS	1	R/W	of the pack	bled, two status bytes will be appended to the payload ket. The status bytes contain RSSI and LQI values, as cRC OK flag.
1:0	ADR_CHK[1:0]	0 (00)	R/W	Controls a	ddress check configuration of received packages.
				Setting	Address check configuration
				0 (00)	No address check
				1 (01)	Address check, no broadcast
				2 (10)	Address check, 0 (0x00) broadcast
				3 (11)	Address check, 0 (0x00) and 255 (0xFF) broadcast

0x07: PKTCTRL1 – Packet automation control



Bit	Field Name	Reset	R/W	Description
7	Reserved		R0	
6	WHITE_DATA	1	R/W	Turn data whitening on / off
				0: Whitening off 1: Whitening on
5:4	PKT_FORMAT[1:0]	0 (00)	R/W	Format of RX and TX data
				Setting Packet format
				0 (00) Normal mode, use FIFOs for RX and TX
				1 (01) Serial Synchronous mode, used for backwards compatibility. Data in on GDO0
				2 (10) Random TX mode; sends random data using PN9 generator. Used for test. Works as normal mode, setting 0 (00), in RX.
				3 (11) Asynchronous transparent mode. Data in on GDO0 and Data out on either of the GDO pins
3	Reserved	0	R0	
2	CRC_EN	1	R/W	1: CRC calculation in TX and CRC check in RX enabled
				0: CRC disabled for TX and RX
1:0	LENGTH_CONFIG[1:0]	1 (01)	R/W	Configure the packet length
				Setting Packet length configuration
				0 (00) Fixed length packets, length configured in PKTLEN register
				1 (01) Variable length packets, packet length configured by the first byte after sync word
				2 (10) Enable infinite length packets
				3 (11) Reserved

0x08: PKTCTRL0 – Packet automation control

0x09: ADDR – Device address

Bit	Field Name	Reset	R/W	Description
7:0	DEVICE_ADDR[7:0]	0 (0x00)	R/W	Address used for packet filtration. Optional broadcast addresses are 0 (0x00) and 255 (0xFF).

0x0A: CHANNR - Channel number

Bit	Field Name	Reset	R/W	Description
7:0	CHAN[7:0]	0 (0x00)	R/W	The 8-bit unsigned channel number, which is multiplied by the channel spacing setting and added to the base frequency.

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Bit	Field Name	Reset	R/W	Description
7:5	Reserved		R0	
4:0	FREQ_IF[4:0]	15 (0x0F)	R/W	The desired IF frequency to employ in RX. Subtracted from FS base frequency in RX and controls the digital complex mixer in the demodulator. $f_{IF} = \frac{f_{XOSC}}{2^{10}} \cdot FREQ _ IF$ The default value gives an IF frequency of 381kHz, assuming a 26.0MHz crystal.

0x0B: FSCTRL1 – Frequency synthesizer control

0x0C: FSCTRL0 – Frequency synthesizer control

Bit	Field Name	Reset	R/W	Description
7:0	FREQOFF[7:0]	0 (0x00)	R/W	Frequency offset added to the base frequency before being used by the frequency synthesizer. (2-complement). Resolution is $F_{XTAL}/2^{14}$ (1.59kHz-1.65kHz); range is ±202kHz to ±210kHz, dependent of XTAL frequency.

Bit	Field Name	Reset	R/W	Description
7:6	FREQ[23:22]	0 (00)	R	FREQ[23:22] is always 0 (the FREQ2 register is less than 36 with 26MHz or higher crystal)
5:0	FREQ[21:16]	30 (0x1E)	R/W	FREQ[23:0] is the base frequency for the frequency synthesiser in increments of $F_{XOSC}/2^{16}.$
				$f_{carrier} = \frac{f_{XOSC}}{2^{16}} \cdot FREQ [23:0]$
				The default frequency word gives a base frequency of 800MHz, assuming a 26.0MHz crystal. With the default channel spacing settings, the following FREQ2 values and channel numbers can be used:
				FREQ2 Base frequency Frequency range (CHAN numbers)
				10 (0x0A) 280MHz 300.2MHz-331MHz (101-255)
				11 (0x0B) 306MHz 306MHz-347.8MHz (0-209)
				14 (0x0E) 384MHz 400.2MHz-435MHz (81-255)
				15 (0x0F) 410MHz 410MHz-461MHz (0-255)
				16 (0x10) 436MHz 436MHz-463.8MHz (0-139)
				17 (0x11) 462MHz 462MHz-463.8MHz (0-9)
				30 (0x1E) 800MHz 800.2MHz-851MHz (1-255)
1				31 (0x1F) 826MHz 826MHz-877MHz (0-255)
				32 (0x20) 852MHz 852MHz-903MHz (0-255)
1				33 (0x21) 878MHz 878MHz-927.8MHz (0-249)
1				34 (0x22) 904MHz 904MHz-927.8MHz (0-119)





0x0E: FREQ1 – Frequency control word, middle byte

Bit	Field Name	Reset	R/W	Description
7:0	FREQ[15:8]	196 (0xC4)	R/W	Ref. FREQ2 register

0x0F: FREQ0 – Frequency control word, low byte

Bit	Field Name	Reset	R/W	Description
7:0	FREQ[7:0]	236 (0xEC)	R/W	Ref. FREQ2 register

0x10: MDMCFG4 – Modem configuration

Bit	Field Name	Reset	R/W	Description
7:6	CHANBW_E[1:0]	2 (10)	R/W	
5:4	CHANBW_M[1:0]	0 (00)	R/W	Sets the decimation ratio for the delta-sigma ADC input stream and thus the channel bandwidth. $BW_{channel} = \frac{f_{XOSC}}{8 \cdot (4 + CHANBW _M) \cdot 2^{CHANBW _E}}$ The default values give 203kHz channel filter bandwidth, assuming a 26.0MHz crystal.
3:0	DRATE_E[3:0]	12 (1100)	R/W	The exponent of the user specified symbol rate

0x11: MDMCFG3 – Modem configuration

Field Name	Reset	R/W	Description
DRATE_M[7:0]	34 (0x22)	R/W	The mantissa of the user specified symbol rate. The symbol rate is configured using an unsigned, floating-point number with 9-bit mantissa and 4-bit exponent. The 9 th bit is a hidden '1'. The resulting data rate is: $R_{DATA} = \frac{(256 + DRATE _M) \cdot 2^{DRATE_E}}{2^{28}} \cdot f_{XOSC}$ The default values give a data rate of 115.051kbps (closest





Bit	Field Name	Reset	R/W	Descriptio	n
7	DEM_DCFILT_OFF	0	R/W	Disable dig	ital DC blocking filter before demodulator.
				0 = Enable	
				1 = Disable	
				The recommended IF frequency changes when the DC blockin is disabled. Please use SmartRF [®] Studio to calculate correct register setting.	
6:4	MOD_FORMAT[2:0]	0 (000)	R/W	The modula	ation format of the radio signal
				Setting	Modulation format
				0 (000)	FSK
				1 (001)	GFSK
				2 (010)	-
				3 (011)	ASK/OOK
				4 (100)	-
				5 (101)	-
				6 (110)	-
				7 (111)	MSK
				ASK is only	v supported for output powers up to -1 dBm
				MSK is only supported for datarates above 26 kbps	
3	MANCHESTER_EN	0	R/W	Enables Manchester encoding/decoding.	
				0 = Disable	
				1 = Enable	
2:0	SYNC_MODE[2:0]	2 (010)	R/W		sync-word qualifier mode.
					0 (000) and 4 (100) disables preamble and sync nission in TX and preamble and sync word detection
				sync word t RX. Only 19 (001) or 5 (repeated sy	1 (001), 2 (001), 5 (101) and 6 (110) enables 16-bit transmission in TX and 16-bits sync word detection in 5 of 16 bits need to match in RX when using setting 1 101). The values 3 (011) and 7 (111) enables ync word transmission in TX and 32-bits sync word n RX (only 30 of 32 bits need to match).
				Setting	Sync-word qualifier mode
				0 (000)	No preamble/sync
				1 (001)	15/16 sync word bits detected
				2 (010)	16/16 sync word bits detected
				3 (011)	30/32 sync word bits detected
				4 (100)	No preamble/sync, carrier-sense above threshold
				5 (101)	15/16 + carrier-sense above threshold
				6 (110)	16/16 + carrier-sense above threshold
				7 (111)	30/32 + carrier-sense above threshold

0x12: MDMCFG2 – Modem configuration



Bit	Field Name	Reset	R/W	Description		
7	FEC_EN	0	R/W	Enable Forward E packet payload	rror Correction (FEC) with interleaving for	
				0 = Disable		
					supported for fixed packet length mode, i.e. NGTH_CONFIG=0)	
6:4	NUM_PREAMBLE[2:0]	2 (010)	R/W	Sets the minimum	number of preamble bytes to be transmitted	
				Setting	Number of preamble bytes	
				0 (000)	2	
				1 (001)	3	
				2 (010)	4	
				3 (011)	6	
				4 (100)	8	
				5 (101)	12	
				6 (110)	16	
				7 (111)	24	
3:2	Reserved		R0			
1:0	CHANSPC_E[1:0]	2 (10)	R/W	2 bit exponent of c	channel spacing	

0x13: MDMCFG1- Modem configuration

0x14: MDMCFG0- Modem configuration

Bit	Field Name	Reset	R/W	Description
7:0	CHANSPC_M[7:0]	248 (0xF8)	R/W	8-bit mantissa of channel spacing (initial 1 assumed). The channel spacing is multiplied by the channel number CHAN and added to the base frequency. It is unsigned and has the format: $\Delta f_{CHANNEL} = \frac{f_{XOSC}}{2^{18}} \cdot (256 + CHANSPC _M) \cdot 2^{CHANSPC _E} \cdot CHAN$ The default values give 199.951kHz channel spacing (the closest setting to 200kHz), assuming 26.0MHz crystal frequency.

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Bit **Field Name** Reset R/W Description 7 Reserved R0 6:4 DEVIATION_E[2:0] 4 (100) R/W Deviation exponent 3 R0 Reserved 2:0 DEVIATION_M[2:0] 7 (111) R/W When MSK modulation is enabled: Sets fraction of symbol period used for phase change. Refer to the SmartRF® Studio software for correct deviation setting when using MSK. When FSK/GFSK modulation is enabled: Deviation mantissa, interpreted as a 4-bit value with MSB implicit 1. The resulting frequency deviation is given by: $f_{dev} = \frac{f_{xosc}}{2^{17}} \cdot (8 + DEVIATION _M) \cdot 2^{DEVIATION_E}$ The default values give ±47.607kHz deviation, assuming 26.0MHz crystal frequency.

0x15: DEVIATN – Modem deviation setting

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0x16: MCSM2	– Main Radio Co	ontrol State Machir	e configuration
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Bit	Field Nam	e	Reset	R/W	Description			
7:5	Reserved		R0		Reserved			
4	RX_TIME_	RSSI	0	R/W	Direct RX termination based on RSSI measurement (carrier sense). For ASK/OOK modulation, RX times out if there is no carrier sense in the first 8 symbol periods.			
3	RX_TIME_	QUAL	L 0		When the RX_TIME timer expires, the chip checks if sync w is found when RX_TIME_QUAL=0, or either sync word is for or PQI is set when RX_TIME_QUAL=1.			
2:0	RX_TIME[IME[2:0] 7 (111)		R/W	Timeout for sync word search in RX. The timeout is relative to the programmed EVENT0 timeout, which means that the duty cycle can be set in wake-on-radio (WOR) mode.			
	The RX timeout in µs is given by EVENT0 C(RX_TIME, WOR_RES), where C is given by the table below (XOSC = 26 MHz):							
	Setting	WOR_RES = 0	WOR_RE	S = 1	WOR_RES = 2	WOR_RES = 3		
	0 (000)	3.6058	18.0288		32.4519	46.8750		
	1 (001)	1.8029	9.0144		16.2260	23.4375		
	2 (010)	0.9014	4.5072		8.1130	11.7188		
	3 (011)	0.4507	2.2536		4.0565	5.8594		
	4 (100)	0.2254	1.1268		2.0282	2.9297		
	5 (101)	0.1127	0.5634		1.0141	1.4648		
	6 (110)	0.0563	0.2817		0.5071	0.7324		
	7 (111) Until end of packet							
	As an example, EVENT0 = 34666, WOR_RES = 0 and RX_TIME = 6 corresponds to 1.96 ms RX timeout, 1 s polling interval and 0.195% duty cycle. Note that WOR_RES should be 0 or 1 when using WOR.							
	The duty c	ycle is approximat	ed by:					
	Setting	WOR_RES = 0	WOR_RE	S = 1				
	0 (000)	12.50%	1.95%					
	1 (001)	6.250%	9765ppm					
	2 (010)	3.125%	4883ppm					
	3 (011)	1.563%	2441ppm					
	4 (100)	0.781%	NA NA					
	5 (101)	0.391%						
	6 (110)	0.195%	NA					
	7 (111) Until end of packet							
	periods. W The timeor	OR mode does no	ot need to be on is limited: \	enabled With RX_	_TIME=0, the timeou		ut counts RC oscillator he 13MSBs of EVENT0,	





Bit	Field Name	Reset	R/W	Description		
7:6	Reserved		R0			
5:4	CCA_MODE[1:0]	3 (11)	R/W	Selects CCA_MODE; Reflected in CCA signal		
				Setting	Clear channel indication	
				0 (00)	Always	
				1 (01)	If RSSI below threshold	
				2 (10)	Unless currently receiving a packet	
				3 (11)	If RSSI below threshold unless currently receiving a packet	
3:2	RXOFF_MODE[1:0]	0 (00)	R/W	Select what should happen when a packet has been received		
				Setting Next state after finishing packet reception		
				0 (00)	IDLE	
				1 (01)	FSTXON	
				2 (10)	тх	
				3 (11)	Stay in RX	
				It is not possible to set RXOFF_MODE to be TX or FSTXON and at the same time use CCA.		
1:0	TXOFF_MODE[1:0]	0 (00)	R/W	Select what should happen when a packet has been sent (TX)		
				Setting	Next state after finishing packet transmission	
				0 (00)	IDLE	
				1 (01)	FSTXON	
				2 (10)	Stay in TX (start sending preamble)	
				3 (11)	RX	

0x17: MCSM1- Main Radio Control State Machine configuration



Bit	Field Name	Reset	R/W	Description			
7:6	Reserved		R0				
5:4	FS_AUTOCAL[1:0]	0 (00)	R/W	Automatically calibrate when going to RX or TX, or back to IDLE			
				Setting	Setting When to perform automatic calibration		
				0 (00)	Never (manual	y calibrate using SCAL strobe)
				1 (01)	When going fro	m IDLE to RX or TX (or FSTX	ON)
				2 (10)	When going fro	m RX or TX back to IDLE	
				3 (11)	Every 4 th time v	vhen going from RX or TX to ID	DLE
				In some automatic wake-on-radio (WOR) applications, using setting 3 (11) can significantly reduce current consumption.			
3:2	PO_TIMEOUT	1 (01)	R/W	Programs the number of times the six-bit ripple counter must expire after XOSC has stabilized before CHP_RDYn goes low.			
				If XOSC is on (stable) during power-down, PO_TIMEOUT should be set so that the regulated digital supply voltage has time to stabilize before CHIP_RDYn goes low (PO_TIMEOUT = 2 recommended).			
				If XOSC is off during power-down, the regulated digital supply voltage has time to stabilize while waiting for the crystal to be stable and PO_TIMEOUT can be set to 0.			
				Setting	Expire count	Timeout after XOSC start	
				0 (00)	1	Approx. 2.3 – 2.4 µs	
				1 (01)	16	Approx. 37 – 39 µs	
				2 (10)	64	Approx. 149 – 155 µs	
				3 (11)	256	Approx. 597 – 620 µs	
				Exact timeout depends on crystal frequency.			
1	PIN_CTRL_EN	0	R/W	Enables the pin radio control option			
0	XOSC_FORCE_ON	0	R/W	Force the XOSC to stay on in the SLEEP state.			

0x18: MCSM0- Main Radio Control State Machine configuration

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Bit	Field Name	Reset	R/W	Description	ı
7:6	Reserved		R0		
5	FOC_BS_CS_GATE	1	R/W	compensatio	emodulator freezes the frequency offset on and clock recovery feedback loops until the SENSE signal goes high.
4:3	FOC_PRE_K[1:0]	2 (10)	R/W	The frequen word is dete	ncy compensation loop gain to be used before a sync
				Setting	Freq. compensation loop gain before sync word
				0 (00)	К
				1 (01)	2K
				2 (10)	ЗК
				3 (11)	4 <i>K</i>
2	FOC_POST_K	1	R/W	The frequen word is dete	ncy compensation loop gain to be used after a sync ected.
				Setting	Freq. compensation loop gain after sync word
				0	Same as FOC_PRE_K
				1	K/2
1:0	FOC_LIMIT[1:0]	2 (10)	R/W	The saturati algorithm:	ion point for the frequency offset compensation
				Setting	Saturation point (max compensated offset)
				0 (00)	±0 (no frequency offset compensation)
				1 (01)	±BW _{CHAN} /8
				2 (10)	±BW _{CHAN} /4
				3 (11)	±BW _{CHAN} /2
					offset compensation is not supported for OOK; FOC_LIMIT=0 with these modulation formats.



Bit	Field Name	Reset	R/W	Description		
7:6	BS_PRE_KI[1:0]	1 (01)	R/W		ecovery feedback loop integral gain to be used before a is detected (used to correct offsets in data rate):	
				Setting	Clock recovery loop integral gain before sync word	
				0 (00)	K ₁	
				1 (01)	2 <i>K</i> ₁	
				2 (10)	3 <i>K</i> /	
				3 (11)	4 <i>K</i> ₁	
5:4	BS_PRE_KP[1:0]	2 (10)	R/W		ecovery feedback loop proportional gain to be used no word is detected.	
				Setting	Clock recovery loop proportional gain before sync word	
				0 (00)	Kp	
				1 (01)	2 <i>K</i> _P	
				2 (10)	3 <i>K</i> _₽	
				3 (11)	4 <i>K</i> _₽	
3	BS_POST_KI	1	R/W		ecovery feedback loop integral gain to be used after a is detected.	
				Setting	Clock recovery loop integral gain after sync word	
				0	Same as BS_PRE_KI	
				1	K ₁ /2	
2	BS_POST_KP	1	R/W		ecovery feedback loop proportional gain to be used after d is detected.	
				Setting	Clock recovery loop proportional gain after sync word	
				0	Same as BS_PRE_KP	
				1	Kp	
1:0	BS_LIMIT[1:0]	0 (00)	R/W	The saturat	tion point for the data rate offset compensation algorithm:	
				Setting	Data rate offset saturation (max data rate difference)	
				0 (00)	±0 (No data rate offset compensation performed)	
				1 (01)	±3.125% data rate offset	

0x1A: BSCFG – Bit Synchronization configuration

2 (10)

3 (11)

±6.25% data rate offset

±12.5% data rate offset



Bit	Field Name	Reset	R/W	Description	Description	
7:6	MAX_DVGA_GAIN[1:0]	0 (00)	R/W	Reduces the	e maximum allowable DVGA gain.	
				Setting	Allowable DVGA settings	
				0 (00)	All gain settings can be used	
				1 (01)	The highest gain setting can not be used	
				2 (10)	The 2 highest gain settings can not be used	
				3 (11)	The 3 highest gain settings can not be used	
5:3	MAX_LNA_GAIN[2:0]	0 (000)	R/W	Sets the max maximum po	ximum allowable LNA + LNA 2 gain relative to the ossible gain.	Э
				Setting	Maximum allowable LNA + LNA 2 gain	
				0 (000)	Maximum possible LNA + LNA 2 gain	
				1 (001)	Approx. 2.6 dB below maximum possible gain	
				2 (010)	Approx. 6.1 dB below maximum possible gain	
				3 (011)	Approx. 7.4 dB below maximum possible gain	
				4 (100)	Approx. 9.2 dB below maximum possible gain	
				5 (101)	Approx. 11.5 dB below maximum possible gain	
				6 (110)	Approx. 14.6 dB below maximum possible gain	
				7 (111)	Approx. 17.1 dB below maximum possible gain	
2:0	MAGN_TARGET[2:0]	3 (011)	R/W		et the target value for the averaged amplitude fro nannel filter (1 LSB = 0 dB).	m
				Setting	Target amplitude from channel filter	
				0 (000)	24 dB	
				1 (001)	27 dB	
				2 (010)	30 dB	
				3 (011)	33 dB	
				4 (100)	36 dB	
				5 (101)	38 dB	
				6 (110)	40 dB	
				7 (111)	42 dB	

0x1B: AGCCTRL2 - AGC control



0x1C: AGCCTRL1 - AGC control

Bit	Field Name	Reset	R/W	Description		
7	Reserved		R0			
6	AGC_LNA_PRIORITY	1	R/W	R/W Selects between two different strategies for LNA and LNA 2 gain adjustment. When 1, the LNA gain is decreased first. When 0, the LNA 2 gain is decreased to minimum before decreasing LNA gain.		
5:4	CARRIER_SENSE_REL_THR[1:0]	0 (00)	R/W	Sets the relat sense	tive change threshold for asserting carrier	
				Setting	Carrier sense relative threshold	
				0 (00)	Relative carrier sense threshold disabled	
				1 (01)	6 dB increase in RSSI value	
				2 (10)	10 dB increase in RSSI value	
				3 (11)	14 dB increase in RSSI value	
3:0	CARRIER_SENSE_ABS_THR[3:0]	0 (0000)	R/W	R/W Sets the absolute RSSI threshold for asserting carrier sense. The 2-complement signed threshold is programmed in steps of 1 dB and is relative to the MAGN_TARGET setting.		
				Setting	Carrier sense absolute threshold	
					(Equal to channel filter amplitude when AGC has not decreased gain)	
				-8 (1000)	Absolute carrier sense threshold disabled	
				-7 (1001)	7 dB below MAGN_TARGET setting	
				-1 (1111)	1 dB below MAGN_TARGET setting	
				0 (0000)	At MAGN_TARGET setting	
				1 (0001)	1 dB above MAGN_TARGET setting	
				7 (0111)	7 dB above MAGN_TARGET setting	

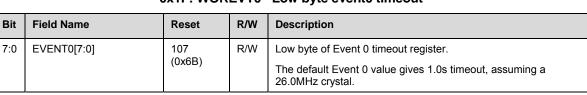




Bit	Field Name	Reset	R/W	Descriptio	n	
7:6	HYST_LEVEL[1:0]	2 (10)	R/W		vel of hysteresis on the magni that determine gain changes	
				Setting	Description	
				0 (00)	No hysteresis, small symm gain	etric dead zone, high
				1 (01)	Low hysteresis, small asyn medium gain	nmetric dead zone,
				2 (10)	Medium hysteresis, mediur zone, medium gain	m asymmetric dead
				3 (11)	Large hysteresis, large asy low gain	/mmetric dead zone,
5:4	WAIT_TIME[1:0]	1 (01)	R/W	adjustment	mber of channel filter sample has been made until the AGC ng new samples.	
				Setting	Channel filter samples	
				0 (00)	8	
				1 (01)	16	
				2 (10)	24	
				3 (11)	32	
3:2	AGC_FREEZE[1:0]	0 (00)	R/W	Control whe	en the AGC gain should be fro	ozen.
				Setting	Function	
				0 (00)	Normal operation. Always ad required.	just gain when
				1 (01)	The gain setting is frozen who been found.	en a sync word has
				2 (10)	Manually freeze the analogue continue to adjust the digital g	
				3 (11)	Manually freezes both the an digital gain setting. Used for r the gain.	
1:0	FILTER_LENGTH[1:0]	1 (01)	R/W		eraging length for the amplitu he ASK decision boundary for	
				Setting	Channel filter samples	
				0 (00)	8	
				1 (01)	16	
				2 (10)	32	
				3 (11)	64	

0x1E: WOREVT1 – High byte event0 timeout

Bit	Field Name	Reset	R/W	Description
7:0	EVENT0[15:8]	135 (0x87)	R/W	High byte of Event 0 timeout register
				$t_{Event0} = \frac{750}{f_{xOSC}} \cdot EVENT0 \cdot 2^{5 \cdot WOR_RES}$



0x1F: WOREVT0 –Low byte event0 timeout

Field Name Bit Reset R/W Description 7 RC_PD 1 R/W Power down signal to RC oscillator. When written to 0, automatic initial calibration will be performed 6:4 EVENT1[2:0] 7 (111) R/W Timeout setting from register block. Decoded to Event 1 timeout. RC oscillator clock frequency equals F_{xosc}/750, which is 34.7 -36 kHz, depending on crystal frequency. The table below lists the number of clock periods after Event 0 before Event 1 times out. Setting WOR_AUTOSYNC=0 WOR_AUTOSYNC=1 16 (0.444ms - 0.462ms) 0 (000) 4 (0.111 – 0.115 ms) 1 (001) 6 (0.167 - 0.173 ms) 24 (0.667ms - 0.692ms) 2 (010) 8 (0.222 - 0.230 ms) 32 (0.889ms - 0.923ms) 3 (011) 12 (0.333 - 0.346 ms) 48 (1.333ms - 1.385ms) 4 (100) 16 (0.444 - 0.462 ms) 64 (1.778ms - 1.846ms) 5 (101) 24 (0.667 - 0.692 ms) 96 (2.667ms - 2.769ms) 6 (110) 32 (0.889 - 0.923 ms) 128 (3.556ms - 3.69ms) 48 (1.333 – 1.385 ms) 7 (111) 192 (5.333ms - 5.54ms) 3 RC CAL 1 R/W Enables (1) or disables (0) the RC oscillator calibration. Included for test purposes only. 2 R0 Reserved 1:0 WOR_RES 0 (00) R/W Controls the Event 0 resolution and maximum timeout of the WOR module: Setting Resolution (1 LSB) Max timeout 0 (00) 1 period (28µs - 29µs) 1.8 - 1.9 seconds 1 (01) 2⁵ periods (0.89ms -0.92 ms) 58 - 61 seconds 2 (10) Do not use N/A 3 (11) Do not use N/A Adjusting the resolution does not affect the resolution of the WOR time readout registers WORTIME1/WORTIME0.

0x20: WORCTRL – Wake On Radio control

0x21: FREND1 – Front end RX configuration

Bit	Field Name	Reset	R/W	Description
7:6	LNA_CURRENT[1:0]	1 (01)	R/W	Adjusts front-end LNA PTAT current output
5:4	LNA2MIX_CURRENT[1:0]	1 (01)	R/W	Adjusts front-end PTAT outputs
3:2	LODIV_BUF_CURRENT_RX[1:0]	1 (01)	R/W	Adjusts current in RX LO buffer (LO input to mixer)
1:0	MIX_CURRENT[1:0]	2 (10)	R/W	Adjusts current in mixer



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Bit	Field Name	Reset	R/W	Description
7:6	Reserved		R0	
5:4	LODIV_BUF_CURRENT_ TX[1:0]	1 (01)	R/W	Adjusts current TX LO buffer (input to PA). The value to use in this field is given by the SmartRF $^{\odot}$ Studio software.
3	Reserved		R0	
2:0	PA_POWER[2:0]	0 (000)	R/W	Selects PA power setting. This value is an index to the PATABLE, which can be programmed with up to 8 different PA settings. In ASK mode, this selects the PATABLE index to use when transmitting a '1'. PATABLE index zero is used in ASK when transmitting a '0'. The PATABLE settings from index '0' to the PA_POWER value are used for ASK TX shaping, and for power ramp-up/ramp-down at the start/end of transmission in all TX modulation formats.

0x23: FSCAL3 – Frequency synthesizer calibration

Bit	Field Name	Reset	R/W	Description
7:6	FSCAL3[7:6]	2 (10)	R/W	Frequency synthesizer calibration configuration. The value to write in this field before calibration is given by the SmartRF [®] Studio software.
5:4	CHP_CURR_CAL_EN[1:0]	2 (10)	R/W	Disable charge pump calibration stage when 0
3:0	FSCAL3[3:0]	9 (1001)	R/W	Frequency synthesizer calibration result register. Fast frequency hopping without calibration for each hop can be done by calibrating upfront for each frequency and saving the resulting FSCAL3, FSCAL2 and FSCAL1 register values. Between each frequency hop, calibration can be replaced by writing the FSCAL3, FSCAL2 and FSCAL1 register values corresponding to the next RF frequency.

0x24: FSCAL2 – Frequency synthesizer calibration

Bit	Field Name	Reset	R/W	Description
7:6	Reserved		R0	
5:0	FSCAL2[5:0]	10 (0x0A)	R/W	Frequency synthesizer calibration result register. Fast frequency hopping without calibration for each hop can be done by calibrating upfront for each frequency and saving the resulting FSCAL3, FSCAL2 and FSCAL1 register values. Between each frequency hop, calibration can be replaced by writing the FSCAL3, FSCAL2 and FSCAL1 register values corresponding to the next RF frequency.

Bit	Field Name	Reset	R/W	Description
7:6	Reserved		R0	
5:0	FSCAL1[5:0]	32 (0x20)	R/W	Frequency synthesizer calibration result register. Fast frequency hopping without calibration for each hop can be done by calibrating upfront for each frequency and saving the resulting FSCAL3, FSCAL2 and FSCAL1 register values. Between each frequency hop, calibration can be replaced by writing the FSCAL3, FSCAL2 and FSCAL1 register values corresponding to the next RF frequency.





Bit	Field Name	Reset	R/W	Description
7	Reserved		R0	
6:0	FSCAL0[6:0]	13 (0x0D)	R/W	Frequency synthesizer calibration control. The value to use in this register is given by the SmartRF $^{\odot}$ Studio software.

0x26: FSCAL0 – Frequency synthesizer calibration

0x27: RCCTRL1 – RC oscillator configuration

Bit	Field Name	Reset	R/W	Description
7	Reserved	0	R0	
6:0	RCCTRL1[6:0]	65 (0x41)	R/W	RC oscillator configuration. Do not write to this register.

0x28: RCCTRL0 – RC oscillator configuration

Bit	Field Name	Reset	R/W	Description
7	Reserved	0	R0	
6:0	RCCTRL0[6:0]	0 (0x00)	R/W	RC oscillator configuration. Do not write to this register.

31.2 Configuration Register Details – Registers that loose programming in sleep state

0x29: FSTEST – Frequency synthesizer calibration control

Bit	Field Name	Reset	R/W	Description
7:0	FSTEST[7:0]	89 (0x59)	R/W	For test only. Do not write to this register.

0x2A: PTEST – Production test

Bit	Field Name	Reset	R/W	Description
7:0	PTEST[7:0]	127 (0x7F)	R/W	Writing 0xBF to this register makes the on-chip temperature sensor available in the IDLE state. The default 0x7F value should then be written back before leaving the IDLE state. Other use of this register is for test only.

0x2B: AGCTEST – AGC test

Bit	Field Name	Reset	R/W	Description
7:0	AGCTEST[7:0]	63 (0x3F)	R/W	For test only. Do not write to this register.

0x2C: TEST2 – Various test settings

Bit	Field Name	Reset	R/W	Description
7:0	TEST2[7:0]	136 (0x88)	R/W	The value to use in this register is given by the ${\sf SmartRF}^{\circledast}$ Studio software.





Bit	Field Name	Reset	R/W	Description
7:0	TEST1[7:0]	49 (0x31)	R/W	The value to use in this register is given by the ${\rm Smart}{\rm RF}^{\rm \$}$ Studio software.

0x2D: TEST1 – Various test settings

0x2E: TEST0 – Various test settings

Bit	Field Name	Reset	R/W	Description
7:0	TEST0[7:0]	11 (0x0B)	R/W	The value to use in this register is given by the ${\rm Smart}{\rm RF}^{\otimes}$ Studio software.

31.3 Status register details

0x30 (0xF0): PARTNUM – Chip ID

Bit	Field Name	Reset	R/W	Description
7:0	PARTNUM[7:0]	0 (0x00)	R	Chip part number

0x31 (0xF1): VERSION - Chip ID

Bit	Field Name	Reset	R/W	Description
7:0	VERSION[7:0]	3 (0x03)	R	Chip version number.

0x32 (0xF2): FREQEST – Frequency Offset Estimate from demodulator

Bit	Field Name	Reset	R/W	Description
7:0	FREQOFF_EST		R	The estimated frequency offset (two's complement) of the carrier. Resolution is $F_{XTAL}/2^{14}$ (1.59 - 1.65 kHz); range is ±202 kHz to ±210 kHz, dependent of XTAL frequency. Frequency offset compensation is only supported for FSK, GFSK and MSK modulation. This register will read 0 when using ASK or OOK modulation.

0x33 (0xF3): LQI – Demodulator estimate for Link Quality

Bit	Field Name	Reset	R/W	Description
7	CRC OK		R	The last CRC comparison matched. Cleared when entering/restarting RX mode.
6:0	LQI_EST[6:0]		R	The Link Quality Indicator estimates how easily a received signal can be demodulated. Calculated over the 64 symbols following the sync word (first 8 packet bytes for 2-ary modulation).

0x34 (0xF4): RSSI – Received signal strength indication

Bit	Field Name	Reset	R/W	Description
7:0	RSSI		R	Received signal strength indicator





Bit	Field Name	Reset	R/W	Description		
7:5	Reserved		R0			
4:0	MARC_STATE[4:0]		R	Main Radio C	Control FSM State	
				Value	State name	State (Figure 18, page 41)
				0 (0x00)	SLEEP	SLEEP
				1 (0x01)	IDLE	IDLE
				2 (0x02)	XOFF	XOFF
				3 (0x03)	VCOON_MC	MANCAL
				4 (0x04)	REGON_MC	MANCAL
				5 (0x05)	MANCAL	MANCAL
				6 (0x06)	VCOON	FS_WAKEUP
				7 (0x07)	REGON	FS_WAKEUP
				8 (0x08)	STARTCAL	CALIBRATE
				9 (0x09)	BWBOOST	SETTLING
				10 (0x0A)	FS_LOCK	SETTLING
				11 (0x0B)	IFADCON	SETTLING
				12 (0x0C)	ENDCAL	CALIBRATE
				13 (0x0D)	RX	RX
				14 (0x0E)	RX_END	RX
				15 (0x0F)	RX_RST	RX
				16 (0x10)	TXRX_SWITCH	TXRX_SETTLING
				17 (0x11)	RX_OVERFLOW	RX_OVERFLOW
				18 (0x12)	FSTXON	FSTXON
				19 (0x13)	тх	ТХ
				20 (0x14)	TX_END	ТХ
				21 (0x15)	RXTX_SWITCH	RXTX_SETTLING
				22 (0x16)	TX_UNDERFLOW	TX_UNDERFLOW
				numbers bec		the SLEEP or XOFF state will make the chip enter the FF states.

0x35 (0xF5): MARCSTATE – Main Radio Control State Machine state

0x36 (0xF6): WORTIME1 – High byte of WOR time

Bit	Field Name	Reset	R/W	Description
7:0	TIME[15:8]		R	High byte of timer value in WOR module

0x37 (0xF7): WORTIME0 - Low byte of WOR time

Bit	Field Name	Reset	R/W	Description
7:0	TIME[7:0]		R	Low byte of timer value in WOR module





Bit	Field Name	Reset	R/W	Description
7	CRC_OK		R	The last CRC comparison matched. Cleared when entering/restarting RX mode.
6	CS		R	Carrier sense
5	PQT_REACHED		R	Preamble Quality reached
4	CCA		R	Clear channel assessment
3	SFD		R	Sync word found
2	GDO2		R	Current GDO2 value. Note: the reading gives the non-inverted value irrespective of what IOCFG2.GDO2_INV is programmed to. It is not recommended to check for PLL lock by reading PKTSTATUS[2] with GDO2_CFG = 0x0A.
1	GDO1		R	Current value on GDO1 pin.
0	GDO0		R	Current GDO0 value. Note: the reading gives the non-inverted value irrespective of what IOCFG0.GDO0_INV is programmed to. It is not recommended to check for PLL lock by reading PKTSTATUS[0] with GDO0_CFG = 0x0A.

0x38 (0xF8): PKTSTATUS - Current GDOx status and packet status

0x39 (0xF9): VCO_VC_DAC - Current setting from PLL calibration module

	Bit	Field Name	Reset	R/W	Description
F	7:0	VCO_VC_DAC[7:0]		R	Status register for test only.

0x3A (0xFA): TXBYTES – Underflow and number of bytes

Bit	Field Name	Reset	R/W	Description
7	TXFIFO_UNDERFLOW		R	
6:0	NUM_TXBYTES		R	Number of bytes in TX FIFO

0x3B (0xFB): RXBYTES – Overflow and number of bytes

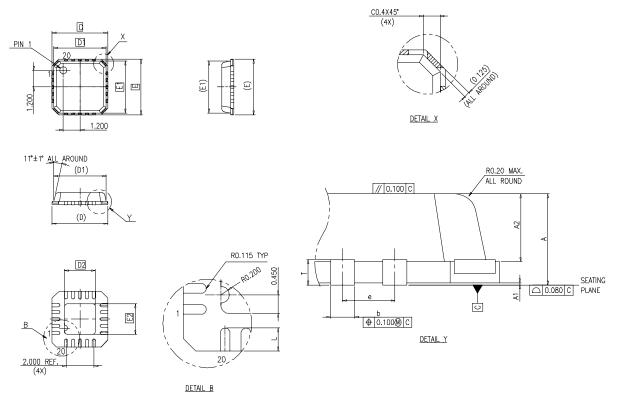
Bit	Field Name	Reset	R/W	Description
7	RXFIFO_OVERFLOW		R	
6:0	NUM_RXBYTES		R	Number of bytes in RX FIFO

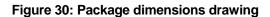




32 Package Description (QLP 20)

All dimensions are in millimetres, angles in degrees. NOTE: The *CC1100* is available in RoHS lead-free package only.





Package type		Α	A1	A2	D	D1	D2	E	E1	E2	L	т	b	е
	Min	0.75	0.005	0.55	3.90	3.65		3.90	3.65		0.45	0.190	0.18	
QLP 20 (4x4)	Тур.	0.85	0.025	0.65	4.00	3.75	2.40	4.00	3.75	2.40	0.55		0.23	0.50
	Max	0.95	0.045	0.75	4.10	3.85		4.10	3.85		0.65	0.245	0.30	

Table 38: Package dimensions

CC1100

2.40mm 2.40mm 0.20mm 0.20mm 0.20mm 0.20mm 0.20mm 0.20mm 0.20mm 0.20mm 0.20mm

32.1 Recommended PCB layout for package (QLP 20)



Note: The figure is an illustration only and not to scale. There are 5 via holes (10 mil diameter) distributed symmetrically in the ground pad under the package. See also the CC1100EM reference design.

32.2 Package thermal properties

Thermal resistance				
Air velocity [m/s]	0			
Rth,j-a [K/W]	40.4			

Table 39: Thermal properties of QLP 20 package

32.3 Soldering information

The recommendations for lead-free reflow in IPC/JEDEC J-STD-020C should be followed.



32.4 Tray specification

CC1100 can be delivered in standard QLP 4x4mm shipping trays.

Tray Specification					
Package	Tray Width	Tray Height	Tray Length	Units per Tray	
QLP 20	125.9mm	7.62mm	322.6mm	490	

Table 40:	Tray	specification
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32.5 Carrier tape and reel specification

Carrier tape and reel is in accordance with EIA Specification 481.

Tape and Reel Specification						
Package	Tape Width	Component Pitch	Hole Pitch	Reel Diameter	Units per Reel	
QLP 20	12 mm	8 mm	4 mm	13 inches	2500	

Table 41: Carrier tape and reel specification

33 Ordering Information

Chipcon Part Number	TI Part Number	Description	Minimum Order Quantity (MOQ)
CC1100-RTY1	CC1100RTK	CC1100 QLP20 RoHS Pb-free 490/tray	490 (tray)
CC1100-RTR1	CC1100RTKR	CC1100 QLP20 RoHS Pb-free 2500/T&R	2,500 (tape and reel)
CC1100-1150DK-433	CC1100-1150DK-433	CC1100/CC1150 -433 MHz Development Kit	1
CC1100-1150DK-868	CC1100-1150DK-868	<i>CC1100/CC1150</i> -868/915 MHz Development Kit	1

Table 42: Ordering Information

34 General Information

34.1 Document History

Revision	Date	Description/Changes
1.1	2006-06-20	Updates to electrical specifications due to increased amount of measurement data. Updated application circuit for 868 MHz. Updated balun component values. Updated current consumption figures in state diagrams. Added figures to table on SPI interface timing requirements. Added information about SPI read. Added table for channel filter bandwidths. Added figure showing data whitening. Updates to text and included new figure in section on arbitrary length configuration. References to SAFC strobe removed. Added information about SPI read. Added information about CRC filtering. Added information about sync word qualifier. Added information on RSSI offset, RSSI update rate, RSSI calculation and typical RSSI curves. Added information on CS and tables with register settings versus CS threshold. Updates to text and included new figures in section on power-on start-up sequence. Changes to wake-on-radio current consumption figures under electrical specifications. Updates to text in section on data FIFO. Corrected formula for calculation of output frequency in Frequency programming section. Added information about to tockeck for PLL lock in section on VCO. Corrected table with PATABLE setting versus output power. Added information on how to interface external clock signal. Added optimal match impedances in RF match section. Better explanation of some of the signals in table of GDO signal selection. Also added some more signals. Added information on system considerations. Added information on timeout for sync word search in RX in register MCSM2. Changes to wake-on-radio control register WORCTRL. WOR_RES[1:0] settings 10 b and 11b changed to NA. Added description of programming bits in registers FOCCFG, BSCFG, AGCCTRL2, Added description of programming bits in registers FOCCFG, BSCFG, AGCCTRL2, AGCCTRL1, AGCCTRL0, FREND1, FSCAL3.
1.0	2005-04-25	First preliminary Data Sheet release

Table 43: Document history

34.2 **Product Status Definitions**

Data Sheet Identification	Product Status	Definition
Advance Information	Planned or Under Development	This data sheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	Engineering Samples and Pre-Production Prototypes	This data sheet contains preliminary data, and supplementary data will be published at a later date. Chipcon reserves the right to make changes at any time without notice in order to improve design and supply the best possible product. The product is not yet fully qualified at this point.
No Identification Noted	Full Production	This data sheet contains the final specifications. Chipcon reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.
Obsolete	Not In Production	This data sheet contains specifications on a product that has been discontinued by Chipcon. The data sheet is printed for reference information only.

Table 44: Product Status Definitions



CC1100

35 Address Information

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36 TI Worldwide Technical Support

Internet

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